

Blackfin Embedded Processor

ADSP-BF539/ADSP-BF539F

FEATURES

Up to 533 MHz high performance Blackfin processor
Two 16-bit MACs, two 40-bit ALUs, four 8-bit video ALUs,
40-bit shifter

RISC-like register and instruction model for ease of programming and compiler friendly support

Advanced debug, trace, and performance monitoring

Wide range of operating voltages; see Operating Conditions on Page 26

Qualified for automotive applications Programmable on-chip voltage regulator 316-ball Pb-free CSP_BGA package

MEMORY

148K bytes of on-chip memory 16K bytes of instruction SRAM/cache 64K bytes of instruction SRAM 32K bytes of data SRAM 32K bytes of data SRAM/cache 4K bytes of scratchpad SRAM

Optional 8M bit parallel flash with boot option

Memory management unit providing memory protection

External memory controller with glueless support for SDRAM, SRAM, flash, and ROM

Flexible memory booting options from SPI and external memory

PERIPHERALS

Parallel peripheral interface (PPI), supporting ITU-R 656 video data formats

- 4 dual-channel, full-duplex synchronous serial ports, supporting 16 stereo I²S channels
- 2 DMA controllers supporting 26 peripheral DMAs
- 4 memory-to-memory DMAs

Controller area network (CAN) 2.0B controller Media transceiver (MXVR) for connection

to a MOST network

3 SPI-compatible ports

Three 32-bit timer/counters with PWM support

3 UARTs with support for IrDA

2 TWI controllers compatible with I²C industry standard

Up to 38 general-purpose I/O pins (GPIO)

Up to 16 general-purpose flag pins (GPF)

Real-time clock, watchdog timer, and 32-bit core timer On-chip PLL capable of frequency multiplication Debug/JTAG interface

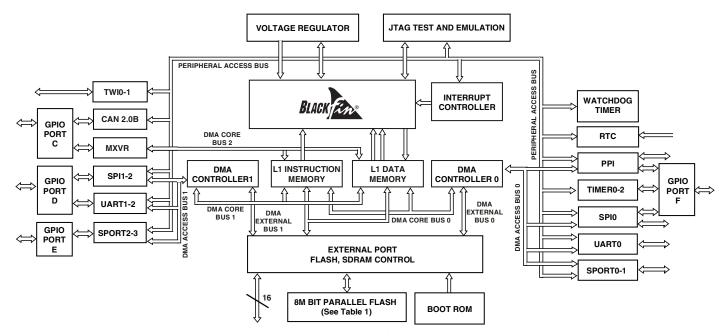


Figure 1. Functional Block Diagram

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Rev. F Document Feedback

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REVISION HISTORY

10/13—Rev. E to Rev. F

| Updated Development Tools | 17 |
|--|----|
| Added notes to Table 32 in Serial Ports—Enable and Three-State | 43 |
| Added Timer Clock Timing | 48 |
| Revised Timer Cycle Timing | 48 |

To view product/process change notifications (PCNs) related to this data sheet revision, please visit the processor's product page on the www.analog.com website and use the View PCN link.

GENERAL DESCRIPTION

The ADSP-BF539/ADSP-BF539F processors are members of the Blackfin® family of products, incorporating the Analog Devices, Inc./Intel Micro Signal Architecture (MSA). Blackfin processors combine a dual-MAC, state-of-the-art signal processing engine, the advantages of a clean, orthogonal RISC-like microprocessor instruction set, and single-instruction, multiple-data (SIMD) multimedia capabilities into a single instruction set architecture.

The ADSP-BF539/ADSP-BF539F processors are completely code compatible with other Blackfin processors, differing only with respect to performance, peripherals, and on-chip memory. These features are shown in Table 1.

By integrating a rich set of industry-leading system peripherals and memory, Blackfin processors are the platform of choice for next generation applications that require RISC-like programmability, multimedia support, and leading edge signal processing in one integrated package.

Table 1. Processor Features

| Feature | ADSP-BF539 | ADSP-BF539F8 |
|-----------------------------------|-----------------------|-----------------------|
| SPORTs | 4 | 4 |
| UARTs | 3 | 3 |
| SPI | 3 | 3 |
| TWI | 2 | 2 |
| CAN | 1 | 1 |
| MXVR | 1 | 1 |
| PPI | 1 | 1 |
| Internal 8M bit Parallel Flash | _ | 1 |
| Instruction SRAM/Cache | 16K bytes | 16K bytes |
| Instruction SRAM | 64K bytes | 64K bytes |
| Data SRAM/Cache | 32K bytes | 32K bytes |
| Data SRAM | 32K bytes | 32K bytes |
| Scratchpad | 4K bytes | 4K bytes |
| Maximum Frequency | 533 MHz 1066 MMACS | 533 MHz 1066 MMACS |
| Package Option | BC-316 | BC-316 |

LOW POWER ARCHITECTURE

Blackfin processors provide world class power management and performance. Blackfin processors are designed in a low power and low voltage design methodology and feature dynamic power management, the ability to vary both the voltage and frequency of operation to significantly lower overall power consumption. Varying the voltage and frequency can result in a substantial reduction in power consumption, compared with simply varying the frequency of operation. This translates into longer battery life and lower heat dissipation.

SYSTEM INTEGRATION

The ADSP-BF539/ADSP-BF539F processors are highly integrated system-on-a-chip solutions for the next generation of industrial and automotive applications including audio and video signal processing. By combining advanced memory configurations, such as on-chip flash memory, with industry-standard interfaces with a high performance signal processing core, users can develop cost-effective solutions quickly without the need for costly external components. The system peripherals include a MOST Network Media Transceiver (MXVR), three UART ports, three SPI ports, four serial ports (SPORT), one CAN interface, two 2-wire interfaces (TWI), four general-purpose timers (three with PWM capability), a real-time clock, a watchdog timer, a parallel peripheral interface, general-purpose I/O, and general-purpose flag pins.

ADSP-BF539/ADSP-BF539F PROCESSOR PERIPHERALS

The ADSP-BF539/ADSP-BF539F processors contain a rich set of peripherals connected to the core via several high bandwidth buses, providing flexibility in system configuration as well as excellent overall system performance (see Figure 1 on Page 1). The general-purpose peripherals include functions such as UART, timers with PWM (pulse-width modulation) and pulse measurement capability, general-purpose flag I/O pins, a realtime clock, and a watchdog timer. This set of functions satisfies a wide variety of typical system support needs and is augmented by the system expansion capabilities of the device. In addition to these general-purpose peripherals, the processors contain high speed serial and parallel ports for interfacing to a variety of audio, video, and modem codec functions. An MXVR transceiver transmits and receives audio and video data and control information on a MOST automotive multimedia network. A CAN 2.0B controller is provided for automotive control networks. An interrupt controller manages interrupts from the onchip peripherals or external sources. And power management control functions tailor the performance and power characteristics of the processor and system to many application scenarios.

All of the peripherals, GPIO, CAN, TWI, real-time clock, and timers, are supported by a flexible DMA structure. There are also four separate memory DMA channels dedicated to data transfers between the processor's various memory spaces, including external SDRAM and asynchronous memory. Multiple on-chip buses running at up to 133 MHz provide enough bandwidth to keep the processor core running along with activity on all of the on-chip and external peripherals.

The ADSP-BF539/ADSP-BF539F processors include an on-chip voltage regulator in support of the processor's dynamic power management capability. The voltage regulator provides a range of core voltage levels from $V_{\mbox{\tiny DDEXT}}.$ The voltage regulator can be bypassed at the user's discretion.

BLACKFIN PROCESSOR CORE

As shown in Figure 2, the Blackfin processor core contains two 16-bit multipliers, two 40-bit accumulators, two 40-bit ALUs, four video ALUs, and a 40-bit shifter. The computation units process 8-bit, 16-bit, or 32-bit data from the register file.

The compute register file contains eight 32-bit registers. When performing compute operations on 16-bit operand data, the register file operates as 16 independent 16-bit registers. All operands for compute operations come from the multiported register file and instruction constant fields.

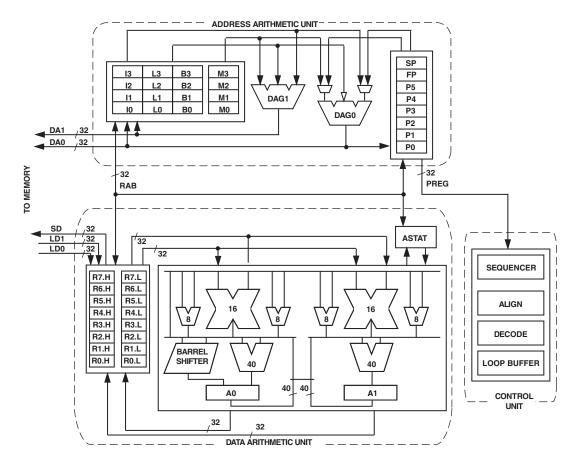


Figure 2. Blackfin Processor Core

Each MAC can perform a 16-bit by 16-bit multiply in each cycle, accumulating the results into the 40-bit accumulators. Signed and unsigned formats, rounding, and saturation are supported.

The ALUs perform a traditional set of arithmetic and logical operations on 16-bit or 32-bit data. In addition, many special instructions are included to accelerate various signal processing tasks. These include bit operations such as field extract and population count, modulo 2³² multiply, divide primitives, saturation and rounding, and sign/exponent detection. The set of video instructions include byte alignment and packing operations 16-bit and 8-bit adds with clipping, 8-bit average operations, and 8-bit subtract/absolute value/accumulate (SAA) operations. Also provided are the compare/select and vector search instructions.

For certain instructions, two 16-bit ALU operations can be performed simultaneously on register pairs (a 16-bit high half and 16-bit low half of a compute register). By also using the second ALU, quad 16-bit operations are possible.

The 40-bit shifter can perform shifts and rotates and is used to support normalization, field extract, and field deposit instructions.

The program sequencer controls the flow of instruction execution, including instruction alignment and decoding. For program flow control, the sequencer supports PC relative and indirect conditional jumps (with static branch prediction), and subroutine calls. Hardware is provided to support zero overhead looping. The architecture is fully interlocked, meaning that the programmer need not manage the pipeline when executing instructions with data dependencies.

The address arithmetic unit provides two addresses for simultaneous dual fetches from memory. It contains a multiported register file consisting of four sets of 32-bit index, modify, length, and base registers (for circular buffering), and eight additional 32-bit pointer registers (for C-style indexed stack manipulation).

Blackfin processors support a modified Harvard architecture in combination with a hierarchical memory structure. Level 1 (L1) memories are those that typically operate at the full processor speed with little or no latency. At the L1 level, the instruction memory holds instructions only. The two data memories hold data, and a dedicated scratchpad data memory stores stack and local variable information.

In addition, multiple L1 memory blocks are provided, offering a configurable mix of SRAM and cache. The memory management Unit (MMU) provides memory protection for individual tasks that can be operating on the core and can protect system registers from unintended access.

The architecture provides three modes of operation: user mode, supervisor mode, and emulation mode. User mode has restricted access to certain system resources, thus providing a protected software environment, while supervisor mode has unrestricted access to the system and core resources.

The Blackfin processor instruction set has been optimized so that 16-bit opcodes represent the most frequently used instructions, resulting in excellent compiled code density. Complex DSP instructions are encoded into 32-bit opcodes, representing fully featured multifunction instructions. Blackfin processors support a limited multi-issue capability, where a 32-bit instruction can be issued in parallel with two 16-bit instructions, allowing the programmer to use many of the core resources in a single instruction cycle.

The Blackfin processor assembly language uses an algebraic syntax for ease of coding and readability. The architecture has been optimized for use in conjunction with the C/C++ compiler, resulting in fast and efficient software implementations.

MEMORY ARCHITECTURE

The ADSP-BF539/ADSP-BF539F processors view memory as a single unified 4G byte address space, using 32-bit addresses. All resources, including internal memory, external memory, and I/O control registers, occupy separate sections of this common address space. The memory portions of this address space are arranged in a hierarchical structure to provide a good cost/performance balance of some very fast, low latency on-chip memory as cache or SRAM, and larger, lower cost and performance off-chip memory systems. See Figure 3.

The L1 memory system is the primary highest performance memory available to the Blackfin processor. The off-chip memory system, accessed through the external bus interface unit (EBIU), provides expansion with SDRAM, flash memory, and SRAM, optionally accessing up to 132M bytes of physical memory.

The memory DMA controller provides high bandwidth data movement capability. It performs block transfers of code or data between the internal memory and the external memory spaces.

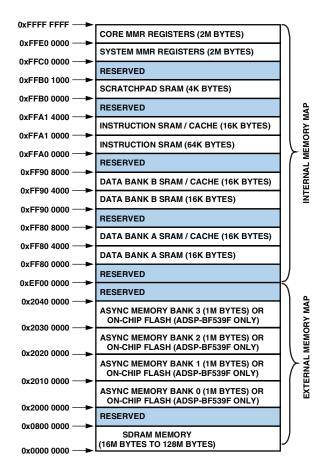


Figure 3. ADSP-BF539/ADSP-BF539F Internal/External Memory Map

Internal (On-Chip) Memory

The ADSP-BF539/ADSP-BF539F processor has three blocks of on-chip memory, providing high bandwidth access to the core.

The first is the L1 instruction memory, consisting of 80K bytes SRAM, of which 16K bytes can be configured as a four-way set-associative cache. This memory is accessed at full processor speed.

The second on-chip memory block is the L1 data memory, consisting of two banks of up to 32K bytes each. Each memory bank is configurable, offering both cache and SRAM functionality. This memory block is accessed at full processor speed.

The third memory block is a 4K byte scratch pad SRAM, which runs at the same speed as the L1 memories, but is only accessible as data SRAM and cannot be configured as cache memory.

External (Off-Chip) Memory

External memory is accessed via the EBIU. This 16-bit interface provides a glueless connection to a bank of synchronous DRAM (SDRAM) as well as up to four banks of asynchronous memory devices including flash, EPROM, ROM, SRAM, and memory mapped I/O devices.

The PC133-compliant SDRAM controller can be programmed to interface to up to 128M bytes of SDRAM. The SDRAM controller allows one row to be open for each internal SDRAM bank, for up to four internal SDRAM banks, improving overall system performance.

The asynchronous memory controller can be programmed to control up to four banks of devices with very flexible timing parameters for a wide variety of devices. Each bank occupies a 1M byte segment regardless of the size of the devices used, so that these banks will only be contiguous if each is fully populated with 1M byte of memory.

Flash Memory (ADSP-BF539F Only)

The ADSP-BF539F8 processor contains a separate flash die, connected to the EBIU bus, within the package of the processor. Figure 4 shows how the flash memory die and Blackfin processor die are connected.

The ADSP-BF539F8 contains an 8M bit $(512K \times 16\text{-bit})$ bottom boot sector Spansion S29AL008J known good die flash memory. Additional information for this product can be found in the Spansion data sheet at www.spansion.com. Features include the following:

- Access times as fast as 70 ns (EBIU registers must be set appropriately)
- · Sector protection
- · One million write cycles per sector
- 20 year data retention

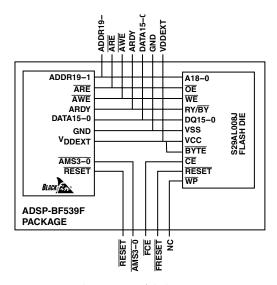


Figure 4. Internal Connection of Flash Memory (ADSP-BF539F8)

The Blackfin processor connects to the flash memory die with address, data, chip enable, write enable, and output enable controls as if it were an external memory device. Note that the write-protect input pin to the flash is not connected and inaccessible, disabling this feature.

The flash chip enable pin \overline{FCE} must be connected to $\overline{AMS0}$ or $\overline{AMS3-1}$ through a printed circuit board trace. When connected to $\overline{AMS0}$, the Blackfin processor can boot from the flash die. When connected to $\overline{AMS3-1}$, the flash memory appears as nonvolatile memory in the processor memory map, shown in Figure 3.

Flash Memory Programming

The ADSP-BF539F8 flash memory can be programmed before or after mounting on the printed circuit board.

To program the flash prior to mounting on the printed circuit board, use a hardware programming tool that can provide the data, address, and control stimuli to the flash die through the external pins on the package. During this programming, V_{DDEXT} and GND must be provided to the package and the Blackfin must be held in reset with bus request (\overline{BR}) asserted and a CLKIN provided.

The VisualDSP++ tools can be used to program the flash memory after the device is mounted on a printed circuit board.

Flash Memory Sector Protection

To use the sector protection feature, a high voltage (+8.5 V to +12.5 V) must be applied to the flash $\overline{\text{FRESET}}$ pin. Refer to the flash data sheet for details.

I/O Memory Space

Blackfin processors do not define a separate I/O space. All resources are mapped through the flat 32-bit address space. Onchip I/O devices have their control registers mapped into memory mapped registers (MMRs) at addresses near the top of the 4G byte address space. These are separated into two smaller blocks, one of which contains the control MMRs for all core functions, and the other of which contains the registers needed for setup and control of the on-chip peripherals outside of the core. The MMRs are accessible only in supervisor mode and appear as reserved space to on-chip peripherals.

Booting

The ADSP-BF539/ADSP-BF539F processors contain a small boot kernel, which configures the appropriate peripheral for booting. If the processors are configured to boot from boot ROM memory space, they start executing from the on-chip boot ROM. For more information, see Booting Modes on Page 16.

Event Handling

The event controller handles all asynchronous and synchronous events to the processor. The processors provide event handling that supports both nesting and prioritization. Nesting allows multiple event service routines to be active simultaneously. Prioritization ensures that servicing of a higher priority event takes precedence over servicing of a lower priority event. The controller provides support for five different types of events:

- Emulation An emulation event causes the processor to enter emulation mode, allowing command and control of the processor via the JTAG interface.
- Reset This event resets the processor.

- Nonmaskable Interrupt (NMI) The NMI event can be generated by the software watchdog timer or by the NMI input signal to the processor. The NMI event is frequently used as a power-down indicator to initiate an orderly shutdown of the system.
- Exceptions Events that occur synchronously to program flow (i.e., the exception will be taken before the instruction is allowed to complete). Conditions such as data alignment violations and undefined instructions cause exceptions.
- Interrupts Events that occur asynchronously to program flow. They are caused by input pins, timers, and other peripherals, as well as by an explicit software instruction.

Each event type has an associated register to hold the return address and an associated return-from-event instruction. When an event is triggered, the state of the processor is saved on the supervisor stack.

The ADSP-BF539/ADSP-BF539F processor's event controller consists of two stages, the core event controller (CEC) and the system interrupt controller (SIC). The core event controller works with the system interrupt controller to prioritize and control all system events. Conceptually, interrupts from the peripherals enter into the SIC and are then routed directly into the general-purpose interrupts of the CEC.

Core Event Controller (CEC)

The CEC supports nine general-purpose interrupts (IVG15-7), in addition to the dedicated interrupt and exception events. Of these general-purpose interrupts, the two lowest priority interrupts (IVG15-14) are recommended to be reserved for software interrupt handlers, leaving seven prioritized interrupt inputs to support the processor's peripherals. Table 2 describes the inputs to the CEC, identifies their names in the event vector table (EVT), and lists their priorities.

System Interrupt Controller (SIC)

The system interrupt controller (SIC) provides the mapping and routing of events from the many peripheral interrupt sources to the prioritized general-purpose interrupt inputs of the CEC. Although the ADSP-BF539/ADSP-BF539F processors provide a default mapping, the user can alter the mappings and priorities of interrupt events by writing the appropriate values into the interrupt assignment registers (SIC_IARx). Table 3 describes the inputs into the SIC and the default mappings into the CEC.

Event Control

The ADSP-BF539/ADSP-BF539F processors provide the user with a very flexible mechanism to control the processing of events. In the CEC, three registers are used to coordinate and control events. Each register is 32 bits wide:

 CEC interrupt latch register (ILAT) – The ILAT register indicates when events have been latched. The appropriate bit is set when the processor has latched the event and is cleared when the event has been accepted into the system. This register is updated automatically by the controller, but it can also be written to clear (cancel) latched events. This

- register may be read while in supervisor mode and may only be written while in supervisor mode when the corresponding IMASK bit is cleared.
- CEC interrupt mask register (IMASK) The IMASK register controls the masking and unmasking of individual events. When a bit is set in the IMASK register, that event is unmasked and will be processed by the CEC when asserted. A cleared bit in the IMASK register masks the event, preventing the processor from servicing the event even though the event can be latched in the ILAT register. This register can be read or written while in supervisor mode. General-purpose interrupts can be globally enabled and disabled with the STI and CLI instructions, respectively.
- CEC interrupt pending register (IPEND) The IPEND register keeps track of all nested events. A set bit in the IPEND register indicates whether the event is currently active or nested at some level. This register is updated automatically by the controller but can be read while in supervisor mode.

The SIC allows further control of event processing by providing three 32-bit interrupt control and status registers. Each register contains a bit corresponding to each of the peripheral interrupt events shown in Table 3 on Page 8.

- SIC interrupt mask registers (SIC_IMASKx) These registers control the masking and unmasking of each peripheral interrupt event. When a bit is set in these registers, that peripheral event is unmasked and will be processed by the system when asserted. A cleared bit in these registers masks the peripheral event, preventing the processor from servicing the event.
- SIC interrupt status registers (SIC_ISRx) As multiple peripherals can be mapped to a single event, these registers allow the software to determine which peripheral event source triggered the interrupt. A set bit indicates that the peripheral is asserting the interrupt, and a cleared bit indicates that the peripheral is not asserting the event.
- SIC interrupt wake-up enable registers (SIC_IWRx) By enabling the corresponding bit in these registers, a peripheral can be configured to wake up the processor, should the core be idled or in sleep mode when the event is generated. (For more information, see Dynamic Power Management on Page 13.)

Because multiple interrupt sources can map to a single generalpurpose interrupt, multiple pulse assertions can occur simultaneously, before or during interrupt processing for an interrupt event already detected on this interrupt input. The IPEND register contents are monitored by the SIC as the interrupt acknowledgement.

The appropriate ILAT register bit is set when an interrupt rising edge is detected (detection requires two core clock cycles). The bit is cleared when the respective IPEND register bit is set. The IPEND bit indicates that the event has entered into the processor pipeline. At this point the CEC will recognize and queue the next rising edge event on the corresponding event input. The minimum latency from the rising edge transition of the

general-purpose interrupt to the IPEND output asserted is three core clock cycles; however, the latency can be much higher, depending on the activity within and the state of the processor.

Table 2. Core Event Controller (CEC)

| Priority | | |
|----------------|------------------------|-----------|
| (0 is Highest) | Event Class | EVT Entry |
| 0 | Emulation/Test Control | EMU |
| 1 | Reset | RST |
| 2 | Nonmaskable Interrupt | NMI |
| 3 | Exception | EVX |
| 4 | Reserved | _ |
| 5 | Hardware Error | IVHW |
| 6 | Core Timer | IVTMR |
| 7 | General Interrupt 7 | IVG7 |
| 8 | General Interrupt 8 | IVG8 |
| 9 | General Interrupt 9 | IVG9 |
| 10 | General Interrupt 10 | IVG10 |
| 11 | General Interrupt 11 | IVG11 |
| 12 | General Interrupt 12 | IVG12 |
| 13 | General Interrupt 13 | IVG13 |
| 14 | General Interrupt 14 | IVG14 |
| 15 | General Interrupt 15 | IVG15 |

Table 3. System and Core Event Mapping

| | Core |
|---------------------------------|-------------------|
| Event Source | Event Name |
| PLL Wake-Up Interrupt | IVG7 |
| DMA Controller 0 Error | IVG7 |
| DMA Controller 1 Error | IVG7 |
| PPI Error Interrupt | IVG7 |
| SPORT0 Error Interrupt | IVG7 |
| SPORT1 Error Interrupt | IVG7 |
| SPORT2 Error Interrupt | IVG7 |
| SPORT3 Error Interrupt | IVG7 |
| MXVR Synchronous Data Interrupt | IVG7 |
| SPI0 Error Interrupt | IVG7 |
| SPI1 Error Interrupt | IVG7 |
| SPI2 Error Interrupt | IVG7 |
| UART0 Error Interrupt | IVG7 |
| UART1 Error Interrupt | IVG7 |
| UART2 Error Interrupt | IVG7 |
| CAN Error Interrupt | IVG7 |
| Real-Time Clock Interrupt | IVG8 |
| DMA0 Interrupt (PPI) | IVG8 |
| DMA1 Interrupt (SPORT0 Rx) | IVG9 |
| DMA2 Interrupt (SPORT0 Tx) | IVG9 |

Table 3. System and Core Event Mapping (Continued)

| Event Source | Core Event Name |
|------------------------------------|--------------------|
| DMA3 Interrupt (SPORT1 Rx) | IVG9 |
| DMA4 Interrupt (SPORT1 Tx) | IVG9 |
| DMA8 Interrupt (SPORT2 Rx) | IVG9 |
| DMA9 Interrupt (SPORT2 Tx) | IVG9 |
| DMA10 Interrupt (SPORT3 Rx) | IVG9 |
| DMA11 Interrupt (SPORT3 Tx) | IVG9 |
| DMA5 Interrupt (SPI0) | IVG10 |
| DMA14 Interrupt (SPI1) | IVG10 |
| DMA15 Interrupt (SPI2) | IVG10 |
| DMA6 Interrupt (UART0 Rx) | IVG10 |
| DMA7 Interrupt (UART0 Tx) | IVG10 |
| DMA16 Interrupt (UART1 Rx) | IVG10 |
| DMA17 Interrupt (UART1 Tx) | IVG10 |
| DMA18 Interrupt (UART2 Rx) | IVG10 |
| DMA19 Interrupt (UART2 Tx) | IVG10 |
| Timer0, Timer1, Timer2 Interrupts | IVG11 |
| TWI0 Interrupt | IVG11 |
| TWI1 Interrupt | IVG11 |
| CAN Receive Interrupt | IVG11 |
| CAN Transmit Interrupt | IVG11 |
| MXVR Status Interrupt | IVG11 |
| MXVR Control Message Interrupt | IVG11 |
| MXVR Asynchronous Packet Interrupt | IVG11 |
| Programmable Flags Interrupts | IVG12 |
| MDMA0 Stream 0 Interrupt | IVG13 |
| MDMA0 Stream 1 Interrupt | IVG13 |
| MDMA1 Stream 0 Interrupt | IVG13 |
| MDMA1 Stream 1 Interrupt | IVG13 |
| Software Watchdog Timer | IVG13 |

DMA CONTROLLERS

The processors have multiple, independent DMA controllers that support automated data transfers with minimal overhead for the processor core. DMA transfers can occur between the ADSP-BF539/ADSP-BF539F processor internal memories and any of its DMA capable peripherals. Additionally, DMA transfers can be accomplished between any of the DMA-capable peripherals and external devices connected to the external memory interfaces, including the SDRAM controller and the asynchronous memory controller. DMA capable peripherals include the SPORTs, SPI ports, UARTs, and PPI. Each individual DMA capable peripheral has at least one dedicated DMA channel. In addition, the MXVR peripheral has its own dedicated DMA controller, which supports its own unique set of operating modes.

The DMA controllers support both 1-dimensional (1-D) and 2-dimensional (2-D) DMA transfers. DMA transfer initialization can be implemented from registers or from sets of parameters called descriptor blocks.

The 2-D DMA capability supports arbitrary row and column sizes up to 64K elements by 64K elements and arbitrary row and column step sizes up to ± 32 K elements. Furthermore, the column step size can be less than the row step size, allowing implementation of interleaved data streams. This feature is especially useful in video applications where data can be deinterleaved on the fly.

Examples of DMA types supported by the processor's DMA controller include:

- A single, linear buffer that stops upon completion
- A circular, auto-refreshing buffer that interrupts on each full or fractionally full buffer
- 1-D or 2-D DMA using a linked list of descriptors
- 2-D DMA using an array of descriptors, specifying only the base DMA address within a common page

In addition to the dedicated peripheral DMA channels, there are four memory DMA channels provided for transfers between the various memories of the ADSP-BF539/ADSP-BF539F processor system. This enables transfers of blocks of data between any of the memories—including external SDRAM, ROM, SRAM, and flash memory—with minimal processor intervention. Memory DMA transfers can be controlled by a very flexible descriptor-based methodology or by a standard register-based autobuffer mechanism.

REAL-TIME CLOCK

The ADSP-BF539/ADSP-BF539F processor real-time clock (RTC) provides a robust set of digital watch features, including current time, stopwatch, and alarm. The RTC is clocked by a 32.768 kHz crystal external to the Blackfin processors. The RTC peripheral has dedicated power supply pins so that it can remain powered up and clocked even when the rest of the processor is in a low power state. The RTC provides several programmable interrupt options, including interrupt per second, minute, hour, or day clock ticks, interrupt on programmable stopwatch count-down, or interrupt at a programmed alarm time.

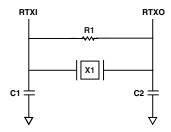
The 32.768 kHz input clock frequency is divided down to a 1 Hz signal by a prescaler. The counter function of the timer consists of four counters: a 60-second counter, a 60-minute counter, a 24-hour counter, and an 32,768-day counter.

When enabled, the alarm function generates an interrupt when the output of the timer matches the programmed value in the alarm control register. There are two alarms: the first alarm is for a time of day. The second alarm is for a day and time of that day.

The stopwatch function counts down from a programmed value, with one second resolution. When the stopwatch is enabled and the counter underflows, an interrupt is generated.

Like the other peripherals, the RTC can wake up the processor from sleep mode upon generation of any RTC wake-up event. Additionally, an RTC wake-up event can wake up the processor from deep sleep mode, and wake up the on-chip internal voltage regulator from a powered down state.

Connect RTC pins RTXI and RTXO with external components as shown in Figure 5.



SUGGESTED COMPONENTS:
ECLIPTEK EC38J (THROUGH-HOLE PACKAGE)
EPSON MC405 12 pF LOAD (SURFACE-MOUNT PACKAGE)
C1 = 22pF
C2 = 22pF
R1 = 10M\Omega
NOTE: C1 AND C2 ARE SPECIFIC TO CRYSTAL SPECIFIED FO

NOTE: C1 AND C2 ARE SPECIFIC TO CRYSTAL SPECIFIED FOR X1. CONTACT CRYSTAL MANUFACTURER FOR DETAILS. C1 AND C2 SPECIFICATIONS ASSUME BOARD TRACE CAPACITANCE OF 3pF.

Figure 5. External Components for RTC

WATCHDOG TIMER

The processors include a 32-bit timer that can be used to implement a software watchdog function. A software watchdog can improve system availability by forcing the processor to a known state through generation of a hardware reset, nonmaskable interrupt (NMI), or general-purpose interrupt, if the timer expires before being reset by software. Programs initialize the count value of the timer, enable the appropriate interrupt, and then enable the timer. Thereafter, the software must reload the counter before it counts to zero from the programmed value. This protects the system from remaining in an unknown state where software, which would normally reset the timer, has stopped running due to an external noise condition or software error.

If configured to generate a hardware reset, the watchdog timer resets both the core and the processor peripherals. After a reset, software can determine if the watchdog was the source of the hardware reset by interrogating a status bit in the watchdog timer control register.

The timer is clocked by the system clock (SCLK), at a maximum frequency of $f_{\rm SCLK}$.

TIMERS

There are four general-purpose programmable timer units in the ADSP-BF539/ADSP-BF539F processors. Three timers have an external pin that can be configured either as a pulse-width modulator (PWM) or timer output, as an input to clock the timer, or as a mechanism for measuring pulse widths and periods of external events. These timers can be synchronized to

an external clock input to the PF1 pin (TACLK), an external clock input to the PPI_CLK pin (TMRCLK), or to the internal SCLK.

The timer units can be used in conjunction with UART0 to measure the width of the pulses in the data stream to provide an auto-baud detect function for a serial channel.

The timers can generate interrupts to the processor core providing periodic events for synchronization, either to the system clock or to a count of external signals.

In addition to the three general-purpose programmable timers, a fourth timer is also provided. This extra timer is clocked by the internal processor clock and is typically used as a system tick clock for generation of operating system periodic interrupts.

SERIAL PORTS (SPORTS)

The ADSP-BF539/ADSP-BF539F processors incorporate four dual-channel synchronous serial ports for serial and multiprocessor communications. The SPORTs support the following features:

- I²S capable operation.
- Bidirectional operation Each SPORT has two sets of independent transmit and receive pins, enabling 16 channels of I²S stereo audio.
- Buffered (8-deep) transmit and receive ports Each port has a data register for transferring data words to and from other processor components and shift registers for shifting data in and out of the data registers.
- Clocking Each transmit and receive port can either use an external serial clock or generate its own, in frequencies ranging from (f_{SCLK}/131,070) Hz to (f_{SCLK}/2) Hz.
- Word length Each SPORT supports serial data words from 3 bits to 32 bits in length, transferred most significant bit first or least significant bit first.
- Framing Each transmit and receive port can run with or without frame sync signals for each data word. Frame sync signals can be generated internally or externally, active high or low, and with either of two pulse widths and early or late frame sync.
- Companding in hardware Each SPORT can perform A-law or μ-law companding according to ITU recommendation G.711. Companding can be selected on the transmit and/or receive channel of the SPORT without additional latencies.
- DMA operations with single-cycle overhead Each SPORT can automatically receive and transmit multiple buffers of memory data. The processor can link or chain sequences of DMA transfers between a SPORT and memory.
- Interrupts Each transmit and receive port generates an interrupt upon completing the transfer of a data word or after transferring an entire data buffer or buffers through DMA.
- Multichannel capability Each SPORT supports 128 channels out of a 1024-channel window and is compatible with the H.100, H.110, MVIP-90, and HMVIP standards.

SERIAL PERIPHERAL INTERFACE (SPI) PORTS

The processors incorporate three SPI-compatible ports that enable the processor to communicate with multiple SPI compatible devices.

The SPI interface uses three pins for transferring data: two data pins (master output-slave input, MOSIx, and master input-slave output, MISOx) and a clock pin (serial clock, SCKx). An SPI chip select input pin (\$\overline{SPIxSS}\$) lets other SPI devices select the processor. For SPI0, seven SPI chip select output pins (\$\overline{SPI0}\$-\$\overline{SEL7}\$-1) let the processor select other SPI devices. SPI1 and SPI2 each have a single SPI chip select output pin (\$\overline{SPI1SEL1}\$ and \$\overline{SPI2SEL1}\$) for SPI point-to-point communication. Each of the SPI select pins is a reconfigured GPIO pin. Using these pins, the SPI ports provide a full-duplex, synchronous serial interface, which supports both master/slave modes and multimaster environments.

The SPI ports' baud rate and clock phase/polarities are programmable, and they each have an integrated DMA controller, configurable to support transmit or receive data streams. Each SPI DMA controller can only service unidirectional accesses at any given time.

The SPI port clock rate is calculated as:

SPI Clock Rate =
$$\frac{f_{SCLK}}{2 \times SPIx \ BAUD}$$

where the 16-bit *SPIx_BAUD* register contains a value of 2 to 65,535.

During transfers, the SPI port simultaneously transmits and receives by serially shifting data in and out on its two serial data lines. The serial clock line synchronizes the shifting and sampling of data on the two serial data lines.

2-WIRE INTERFACE

The processors incorporate two 2-wire interface (TWI) modules that are compatible with the Philips Inter-IC bus standard. The TWI modules offer the capabilities of simultaneous master and slave operation, support for 7-bit addressing, and multimedia data arbitration. The TWI also includes master clock synchronization and support for clock low extension.

The TWI interface uses two pins for transferring clock (SCLx) and data (SDAx) and supports the protocol at speeds up to 400 kbps.

The TWI interface pins are compatible with 5 V logic levels.

UART PORTS

The processors incorporate three full-duplex universal asynchronous receiver/transmitter (UART) ports, which are fully compatible with PC standard UARTs. The UART ports provide a simplified UART interface to other peripherals or hosts, supporting full-duplex, DMA supported, asynchronous transfers of serial data. The UART ports include support for 5 data bits to 8 data bits, 1 stop bit or 2 stop bits, and none, even, or odd parity. The UART ports support two modes of operation:

- PIO (programmed I/O) The processor sends or receives data by writing or reading I/O mapped UART registers.
 The data is double buffered on both transmit and receive.
- DMA (direct memory access) The DMA controller transfers both transmit and receive data. This reduces the number and frequency of interrupts required to transfer data to and from memory. Each UART has two dedicated DMA channels, one for transmit and one for receive. These DMA channels have lower default priority than most DMA channels because of their relatively low service rates.

Each UART port's baud rate, serial data format, error code generation and status, and interrupts are programmable:

- Supporting bit rates ranging from (f_{SCLK}/1,048,576) to (f_{SCLK}/16) bits per second.
- Supporting data formats from 7 bits to 12 bits per frame.
- Both transmit and receive operations can be configured to generate maskable interrupts to the processor.

Each UART port's clock rate is calculated as:

$$UART\ Clock\ Rate\ =\ \frac{f_{SCLK}}{16\times UART_Divisor}$$

where the 16-bit *UART_Divisor* comes from the UARTx_DLH register (most significant 8 bits) and UARTx_DLL register (least significant 8 bits).

In conjunction with the general-purpose timer functions, autobaud detection is supported on UART0.

The capabilities of the UARTs are further extended with support for the Infrared Data Association (IrDA®) Serial Infrared Physical Layer Link Specification (SIR) protocol.

PROGRAMMABLE I/O PINS

The ADSP-BF539/ADSP-BF539F processor has numerous peripherals that may not all be required for every application. Therefore, many of the pins have a secondary function as programmable I/O pins. There are two types of programmable I/O pins with slightly different functionality: programmable flags and general-purpose I/O.

Programmable Flags (GPIO Port F)

There are 16 bidirectional, general-purpose programmable flag (PF15–0) pins on GPIO Port F. Each programmable flag can be individually controlled by manipulation of the flag control, status, and interrupt registers:

- Flag direction control register Specifies the direction of each individual PFx pin as input or output.
- Flag control and status registers The processors employ a "write one to modify" mechanism that allows any combination of individual flags to be modified in a single instruction, without affecting the level of any other flags. Four control registers are provided. One register is written in order to set flag values, one register is written in order to clear flag values, one register is written in order to toggle flag values, and one register is written in order to specify a flag value. Reading the flag status register allows software to interrogate the sense of the flags.

- Flag interrupt mask registers The two flag interrupt mask registers allow each individual PFx pin to function as an interrupt to the processor. Similar to the two flag control registers that are used to set and clear individual flag values, one flag interrupt mask register sets bits to enable interrupt function, and the other flag interrupt mask register clears bits to disable interrupt function. PFx pins defined as inputs can be configured to generate hardware interrupts, while output PFx pins can be triggered by software interrupts.
- Flag interrupt sensitivity registers The two flag interrupt sensitivity registers specify whether individual PFx pins are level- or edge-sensitive and specify—if edge-sensitive— whether just the rising edge or both the rising and falling edges of the signal are significant. One register selects the type of sensitivity, and one register selects which edges are significant for edge-sensitivity.

The PFx pins can also be used by the SPI0 and PPI ports as shown in Table 4, depending on how the peripherals are configured. Care must be taken so that these pins are not used for multiple purposes simultaneously.

General-Purpose I/O Ports C, D, and E

There are 38 general-purpose I/O pins that are multiplexed with other peripherals. They are arranged into Ports C, D, and E as shown in Table 4. The GPIO differ from the programmable flags on Port F in that the GPIO pins cannot generate interrupts to the processor.

Table 4. Programmable Flag/GPIO Ports

| Peripheral | Alternate Programmable Flag/ GPIO Port Function |
|------------|--|
| PPI | PF15-3 |
| SPORT2 | PE7-0 |
| SPORT3 | PE15-8 |
| SPI0 | PF7-0 |
| SPI1 | PD4-0 |
| SPI2 | PD9-5 |
| UART1 | PD11-10 |
| UART2 | PD13-12 |
| CAN | PC1-0 ¹ |
| MXVR | PC9-4 ¹ |

¹ PC1 and PC4 are open-drain when configured as GPIO outputs.

The general-purpose I/O pins can be individually controlled by manipulation of the control and status registers. These pins will not cause interrupts to be generated to the processor but can be polled to determine their status.

- GPIO direction control register Specifies the direction of each individual GPIOx pin as input or output.
- GPIO control and status registers The processors employ a "write one to modify" mechanism that allows any combination of individual GPIO pins to be modified in a single

instruction, without affecting the level of any other GPIO pin. Four control registers and a data register are provided for each GPIO port. One register is written in order to set GPIO pin values, one register is written in order to clear GPIO pin values, one register is written in order to toggle GPIO pin values, and one register is written in order to specify a GPIO input or output. Reading the GPIO data register allows software to determine the state of the input GPIO pins.

Note that the GP pin is used to specify the status of the GPIO pins PC9–PC4 at power up. If GP is tied high, then pins PC9–PC4 are configured as GPIO after reset. The pins cannot be reconfigured through software, and special care must be taken with the MLF pin. If the GP pin is tied low, then the pins are configured as MXVR pins after reset but can be reconfigured as GPIO pins through software.

PARALLEL PERIPHERAL INTERFACE

The ADSP-BF539/ADSP-BF539F processors provide a parallel peripheral interface (PPI) that can connect directly to parallel ADC and DAC converters, video encoders and decoders, and other general-purpose peripherals. The PPI consists of a dedicated input clock pin, up to 3 frame synchronization pins, and up to 16 data pins. The input clock supports parallel data rates up to $f_{\rm SCLK}/2$ MHz, and the synchronization signals can be configured as either inputs or outputs.

The PPI supports a variety of general-purpose and ITU-R 656 modes of operation. In general-purpose mode, the PPI provides half-duplex, bidirectional data transfer with up to 16 bits of data. Up to 3 frame synchronization signals are also provided. In ITU-R 656 mode, the PPI provides half-duplex, bidirectional transfer of 8- or 10-bit video data. Additionally, on-chip decode of embedded start-of-line (SOL) and start-of-field (SOF) preamble packets are supported.

General-Purpose Mode Descriptions

The general-purpose modes of the PPI are intended to suit a wide variety of data capture and transmission applications. Three distinct submodes are supported:

- Input Mode Frame syncs and data are inputs into the PPI.
- Frame Capture Mode Frame syncs are outputs from the PPI, but data are inputs.
- Output Mode Frame syncs and data are outputs from the PPI.

Input Mode

This mode is intended for ADC applications, as well as video communication with hardware signaling. In its simplest form, PPI_FS1 is an external frame sync input that controls when to read data. The PPI_DELAY MMR allows for a delay (in PPI_CLK cycles) between reception of this frame sync and the initiation of data reads. The number of input data samples is user programmable and defined by the contents of the PPI_COUNT register. The PPI supports 8-bit, and 10-bit through 16-bit data and are programmable in the PPI_CONTROL register.

Frame Capture Mode

This mode allows the video source(s) to act as a slave (e.g., for frame capture). The processors control when to read from the video source(s). PPI_FS1 is an HSYNC output, and PPI_FS2 is a VSYNC output.

Output Mode

This mode is used for transmitting video or other data with up to three output frame syncs. Typically, a single frame sync is appropriate for data converter applications, whereas two or three frame syncs could be used for sending video with hardware signaling.

ITU-R 656 Mode Descriptions

The ITU-R 656 modes of the PPI are intended to suit a wide variety of video capture, processing, and transmission applications. Three distinct submodes are supported:

- · Active Video Only Mode
- Vertical Blanking Only Mode
- Entire Field Mode

Active Video Only Mode

This mode is used when only the active video portion of a field is of interest and not any of the blanking intervals. The PPI will not read in any data between the end of active video (EAV) and start of active video (SAV) preamble symbols, or any data present during the vertical blanking intervals. In this mode, the control byte sequences are not stored to memory; they are filtered by the PPI. After synchronizing to the start of Field 1, the PPI ignores incoming samples until it sees an SAV code. The user specifies the number of active video lines per frame (in the PPI_COUNT register).

Vertical Blanking Interval Mode

In this mode, the PPI only transfers vertical blanking interval (VBI) data.

Entire Field Mode

In this mode, the entire incoming bit stream is read in through the PPI. This includes active video, control preamble sequences, and ancillary data that can be embedded in horizontal and vertical blanking intervals. Data transfer starts immediately after synchronization to Field 1.

CONTROLLER AREA NETWORK (CAN) INTERFACE

The ADSP-BF539/ADSP-BF539F processors provide a CAN controller that is a communication controller implementing the controller area network (CAN) V2.0B protocol. This protocol is an asynchronous communications protocol used in both industrial and automotive control systems. CAN is well suited for control applications due to its ability to communicate reliably over a network since the protocol incorporates CRC checking, message error tracking, and fault node confinement.

The CAN controller is based on a 32-entry mailbox RAM and supports both the standard and extended identifier (ID) message formats specified in the CAN protocol specification, Revision 2.0, Part B.

Each mailbox consists of eight 16-bit data words. The data is divided into fields, which includes a message identifier, a time stamp, a byte count, up to 8 bytes of data, and several control bits. Each node monitors the messages being passed on the network. If the identifier in the transmitted message matches an identifier in one of its mailboxes, then the module knows that the message was meant for it, passes the data into its appropriate mailbox, and signals the processor of message arrival with an interrupt.

The CAN controller can wake up the processor from sleep mode upon generation of a wake-up event, such that the processor can be maintained in a low power mode during idle conditions. Additionally, a CAN wake-up event can wake up the on-chip internal voltage regulator from the hibernate state.

The electrical characteristics of each network connection are very stringent; therefore, the CAN interface is typically divided into two parts: a controller and a transceiver. This allows a single controller to support different drivers and CAN networks. The ADSP-BF539/ADSP-BF539F CAN module represents the controller part of the interface. This module's network I/O is a single transmit output and a single receive input, which connect to a line transceiver.

The CAN clock is derived from the processor system clock (SCLK) through a programmable divider and therefore does not require an additional crystal.

MEDIA TRANSCEIVER MAC LAYER (MXVR)

The ADSP-BF539/ADSP-BF539F processors provide a media transceiver (MXVR) MAC layer, allowing the processor to be connected directly to a MOST network through just an FOT or electrical PHY.

The MXVR is fully compatible with industry standard standalone MOST controller devices, supporting 22.579 Mbps or 24.576 Mbps data transfer. It offers faster lock times, greater jitter immunity, and a sophisticated DMA scheme for data transfers. The high speed internal interface to the core and L1 memory allows the full bandwidth of the network to be utilized. The MXVR can operate as either the network master or as a network slave.

Synchronous data is transferred to or from the synchronous data channels through eight programmable DMA engines. The synchronous data DMA engines can operate in various modes, including modes that trigger DMA operation when data patterns are detected in the receive data stream. Furthermore, two DMA engines support asynchronous traffic and control message traffic.

Interrupts are generated when a user-defined amount of synchronous data has been sent or received by the processor or when asynchronous packets or control messages have been sent or received.

The MXVR peripheral can wake up the processor from sleep mode when a wake-up preamble is received over the network or based on any other MXVR interrupt event. Additionally, detection of network activity by the MXVR can be used to wake up the processor from sleep mode and wake up the on-chip internal voltage regulator from the powered-down hibernate state. These features allow the processor to operate in a low-power state when there is no network activity or when data is not currently being received or transmitted by the MXVR.

The MXVR clock is provided through a dedicated external crystal or crystal oscillator. For 44.1 kHz frame syncs, use a 45.1584 MHz crystal or oscillator; for 48 kHz frame syncs, use a 49.152 MHz crystal or oscillator. If using a crystal to provide the MXVR clock, use a parallel-resonant, fundamental mode, microprocessor-grade crystal.

DYNAMIC POWER MANAGEMENT

The ADSP-BF539/ADSP-BF539F processors provide four operating modes, each with a different performance/power profile. In addition, dynamic power management provides the control functions to dynamically alter the processor core supply voltage, further reducing power dissipation. Control of clocking to each of the ADSP-BF539/ADSP-BF539F processor peripherals also reduces power consumption. See Table 5 for a summary of the power settings for each mode.

Full-On Operating Mode—Maximum Performance

In the full-on mode, the PLL is enabled and is not bypassed, providing capability for maximum operational frequency. This is the power-up default execution state in which maximum performance can be achieved. The processor core and all enabled peripherals run at full speed.

Active Operating Mode—Moderate Dynamic Power Savings

In the active mode, the PLL is enabled but bypassed. Because the PLL is bypassed, the processor's core clock (CCLK) and system clock (SCLK) run at the input clock (CLKIN) frequency. DMA access is available to appropriately configured L1 memories.

In the active mode, it is possible to disable the PLL through the PLL Control register (PLL_CTL). If disabled, the PLL must be re-enabled before transitioning to the full-on or sleep modes.

Table 5. Power Settings

| Mode/State | PLL | PLL Bypassed | Core Clock (CCLK) | System Clock (SCLK) | Core Power |
|------------|----------------------|-----------------|-------------------------|---------------------------|---------------|
| Full-On | Enabled | No | Enabled | Enabled | On |
| Active | Enabled/ disabled | Yes | Enabled | Enabled | On |
| Sleep | Enabled | | Disabled | Enabled | On |
| Deep Sleep | Disabled | | Disabled | Disabled | On |
| Hibernate | Disabled | | Disabled | Disabled | Off |

Sleep Operating Mode—High Dynamic Power Savings

The sleep mode reduces dynamic power dissipation by disabling the clock to the processor core (CCLK). The PLL and system clock (SCLK), however, continue to operate in this mode. Typically, an external event or RTC activity wakes up the processor. When in the sleep mode, assertion of a wake-up event enabled in the SIC_IWRx register causes the processor to sense the value of the BYPASS bit in the PLL control register (PLL_CTL). If BYPASS is disabled, the processor transitions to the full on mode. If BYPASS is enabled, the processor will transition to the active mode. When in the sleep mode, system DMA access to L1 memory is not supported.

Deep Sleep Operating Mode—Maximum Dynamic Power Savings

The deep sleep mode maximizes dynamic power savings by disabling the clocks to the processor core (CCLK) and to all synchronous peripherals (SCLK). Asynchronous peripherals such as the RTC may still be running but will not be able to access internal resources or external memory. This powered-down mode can only be exited by assertion of the reset interrupt ($\overline{\text{RESET}}$) or by an asynchronous interrupt generated by the RTC. When in deep sleep mode, an RTC asynchronous interrupt causes the processor to transition to the active mode. Assertion of $\overline{\text{RESET}}$ while in deep sleep mode causes the processor to transition to the full-on mode.

Hibernate State—Maximum Static Power Savings

The hibernate state maximizes static power savings by disabling the voltage and clocks to the processor core (CCLK) and to all the synchronous peripherals (SCLK). The internal voltage regulator for the processor can be shut off by writing b#00 to the FREQ bits of the VR_CTL register. This sets the internal power supply voltage (V_{DDINT}) to 0 V to provide the lowest static power dissipation. Any critical information stored internally (memory contents, register contents, etc.) must be written to a nonvolatile storage device prior to removing power if the processor state is to be preserved. Since V_{DDEXT} can still be supplied in this mode, all of the external pins three-state, unless otherwise specified. This allows other devices that may be connected to the processor to still have power applied without drawing unwanted current. The internal supply regulator can be woken up either by a real-time clock wake-up, by CAN bus traffic, by asserting the \overline{RESET} pin, or by an external source via the \overline{GPW} pin.

Power Savings

As shown in Table 6, the ADSP-BF539/ADSP-BF539F processors support five different power domains. The use of multiple power domains maximizes flexibility, while maintaining compliance with industry standards and conventions:

- The 3.3 V $V_{\rm DDRTC}$ power domain supplies the RTC I/O and logic so that the RTC can remain functional when the rest of the chip is powered off.
- The 3.3 V MXEVDD power domain supplies the MXVR crystal and is separate to provide noise isolation.
- The 1.25 V MPIVDD power domain supplies the MXVR PLL and is separate to provide noise isolation.

- The 1.25 V $V_{\rm DDINT}$ power domain supplies all internal logic except for the RTC logic and the MXVR PLL.

There are no sequencing requirements for the various power domains.

Table 6. Power Domains

| Power Domain | V _{DD} Range |
|--|-----------------------|
| RTC Crystal I/O and Logic | V_{DDRTC} |
| MXVR Crystal I/O | MXEVDD |
| MXVR PLL Analog and Logic | MPIVDD |
| All Internal Logic Except RTC and MXVR PLL | V_{DDINT} |
| All I/O Except RTC and MXVR Crystals | V_{DDEXT} |

The $V_{\rm DDRTC}$ should either be connected to an isolated supply such as a battery (if the RTC is to operate while the rest of the chip is powered down) or should be connected to the $V_{\rm DDEXT}$ plane on the board. The $V_{\rm DDRTC}$ should remain powered when the processor is in hibernate state and should also remain powered even if the RTC functionality is not being used in an application. The MXEVDD should be connected to the $V_{\rm DDEXT}$ plane on the board at a single location with local bypass capacitors. The MXEVDD should remain powered when the processor is in hibernate state and should also remain powered even when the MXVR functionality is not being used in an application. The MPIVDD should be connected to the $V_{\rm DDINT}$ plane on the board at a single location through a ferrite bead with local bypass capacitors.

The power dissipated by a processor is largely a function of the clock frequency of the processor and the square of the operating voltage. For example, reducing the clock frequency by 25% results in a 25% reduction in dynamic power dissipation, while reducing the voltage by 25% reduces dynamic power dissipation by more than 40%. Further, these power savings are additive in that, if the clock frequency and supply voltage are both reduced, the power savings can be dramatic.

The dynamic power management feature of the ADSP-BF539/ADSP-BF539F processors allow both the processor input voltage ($V_{\rm DDINT}$) and clock frequency ($f_{\rm CCLK}$) to be dynamically controlled.

The savings in power dissipation can be modeled using the power savings factor and % power savings calculations.

The power savings factor is calculated as

Power Savings Factor

$$= \frac{f_{CCLKRED}}{f_{CCLKNOM}} \times \left(\frac{V_{DDINTRED}}{V_{DDINTNOM}}\right)^2 \times \left(\frac{t_{RED}}{t_{NOM}}\right)$$

where:

 $f_{CCLKNOM}$ is the nominal core clock frequency.

 $f_{CCLKRED}$ is the reduced core clock frequency.

 $V_{DDINTNOM}$ is the nominal internal supply voltage.

 $V_{DDINTRED}$ is the reduced internal supply voltage.

 t_{NOM} is the duration running at $f_{CCLKNOM}$.

 t_{RED} is the duration running at $f_{CCLKRED}$.

The Power Savings Factor is calculated as

% Power Savings = $(1 - Power Savings Factor) \times 100\%$

VOLTAGE REGULATION

The Blackfin processors provide an on-chip voltage regulator that can generate appropriate $V_{\rm DDINT}$ voltage levels from the $V_{\rm DDEXT}$ supply. See Operating Conditions on Page 26 for regulator tolerances and acceptable $V_{\rm DDEXT}$ ranges for specific models. †

The regulator controls the internal logic voltage levels and is programmable with the voltage regulator control register (VR_CTL) in increments of 50 mV. To reduce standby power consumption, the internal voltage regulator can be programmed to remove power to the processor core while I/O power (V_DDRTC, MXEVDD, V_DDEXT) is still supplied. While in the hibernate state, I/O power is still being applied, eliminating the need for external buffers. The voltage regulator can be activated from this power-down state through an RTC wake-up, a CAN wake-up, an MXVR wake-up, a general-purpose wake-up, or by asserting $\overline{\text{RESET}}$, all of which will then initiate a boot sequence. The regulator can also be disabled and bypassed at the user's discretion.

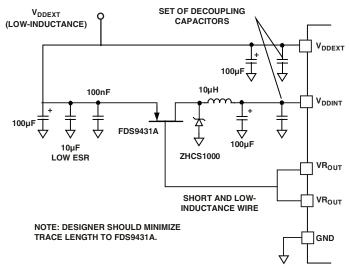


Figure 6. Voltage Regulator Circuit

CLOCK SIGNALS

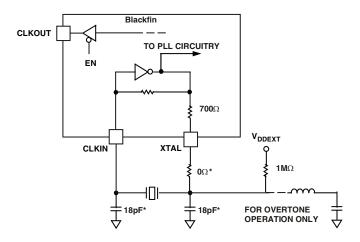
The ADSP-BF539/ADSP-BF539F processors can be clocked by an external crystal, a sine wave input, or a buffered, shaped clock derived from an external clock oscillator.

[†] See Switching Regulator Design Considerations for ADSP-BF533 Blackfin Processors (EE-228). If an external clock is used, it should be a TTL-compatible signal and must not be halted, changed, or operated below the specified frequency during normal operation. This signal is connected to the processor's CLKIN pin. When an external clock is used, the XTAL pin must be left unconnected.

Alternatively, because the processors include an on-chip oscillator circuit, an external crystal can be used. For fundamental frequency operation, use the circuit shown in Figure 7. A parallel-resonant, fundamental frequency, microprocessor-grade crystal is connected across the CLKIN and XTAL pins. The onchip resistance between CLKIN and the XTAL pin is in the 500 kW range. Further parallel resistors are typically not recommended. The two capacitors and the series resistor, shown in Figure 7, fine tune the phase and amplitude of the sine frequency. The capacitor and resistor values, shown in Figure 7, are typical values only. The capacitor values are dependent upon the crystal manufacturer's load capacitance recommendations and the physical PCB layout. The resistor value depends on the drive level specified by the crystal manufacturer. System designs should verify the customized values based on careful investigation on multiple devices over the allowed temperature range.

A third-overtone crystal can be used at frequencies above 25 MHz. The circuit is then modified to ensure crystal operation only at the third overtone, by adding a tuned inductor circuit as shown in Figure 7.

As shown in Figure 8 on Page 16, the core clock (CCLK) and system peripheral clock (SCLK) are derived from the input clock (CLKIN) signal. An on-chip PLL is capable of multiplying the CLKIN signal by a user programmable 0.5× to 64× multiplication factor (bounded by specified minimum and maximum VCO frequencies). The default multiplier is 10×, but it can be modified by a software instruction sequence. On-the-fly frequency changes can be effected by simply writing to the PLL_DIV register.



NOTE: VALUES MARKED WITH * MUST BE CUSTOMIZED DEPENDING ON THE CRYSTAL AND LAYOUT. PLEASE ANALYZE CAREFULLY.

Figure 7. External Crystal Connections

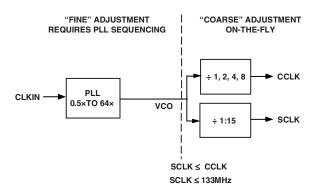


Figure 8. Frequency Modification Methods

All on-chip peripherals are clocked by the system clock (SCLK). The system clock frequency is programmable by means of the SSEL3–0 bits of the PLL_DIV register. The values programmed into the SSEL fields define a divide ratio between the PLL output (VCO) and the system clock. SCLK divider values are 1 through 15. Table 7 illustrates typical system clock ratios.

Table 7. Example System Clock Ratios

| - | Divider Ratio | Example Frequency Ratios (MHz) | |
|---------|---------------|--------------------------------|------|
| SSEL3-0 | VCO/SCLK | vco | SCLK |
| 0001 | 1:1 | 100 | 100 |
| 0110 | 6:1 | 300 | 50 |
| 1010 | 10:1 | 500 | 50 |

The maximum frequency of the system clock is f_{SCLK} . Note that the divisor ratio must be chosen to limit the system clock frequency to its maximum of f_{SCLK} . The SSEL value can be changed dynamically without any PLL lock latencies by writing the appropriate values to the PLL divisor register (PLL_DIV).

Note that when the SSEL value is changed, it will affect all the peripherals that derive their clock signals from the SCLK signal.

The core clock (CCLK) frequency can also be dynamically changed by means of the CSEL1–0 bits of the PLL_DIV register. Supported CCLK divider ratios are 1, 2, 4, and 8, as shown in Table 8. This programmable core clock capability is useful for fast core frequency modifications.

Table 8. Core Clock Ratios

| - | Divider Ratio | Example Frequency Ratios | | |
|---------|---------------|---------------------------------|------|--|
| CSEL1-0 | VCO/CCLK | vco | CCLK | |
| 00 | 1:1 | 300 | 300 | |
| 01 | 2:1 | 300 | 150 | |
| 10 | 4:1 | 500 | 125 | |
| 11 | 8:1 | 200 | 25 | |

BOOTING MODES

The ADSP-BF539/ADSP-BF539F processors have three mechanisms (listed in Table 9) for automatically loading internal L1 instruction memory after a reset. A fourth mode is provided to execute from external memory, bypassing the boot sequence.

Table 9. Booting Modes

| BMODE1-0 | Description |
|----------|---|
| 00 | Execute from 16-bit external memory (bypass boot ROM) |
| 01 | Boot from 8-bit or 16-bit flash or boot from on-chip flash (ADSP-BF539F only) |
| 10 | Boot from SPI serial master connected to SPI0 |
| 11 | Boot from SPI serial slave EEPROM/flash (8-,16-, or 24-bit address range, or Atmel AT45DB041, AT45DB081, or AT45DB161serial flash) connected to SPI0 |

The BMODE pins of the reset configuration register, sampled during power-on resets and software initiated resets, implement the following modes:

- Execute from 16-bit external memory Execution starts from address 0x2000 0000 with 16-bit packing. The boot ROM is bypassed in this mode. All configuration settings are set for the slowest device possible (3-cycle hold time; 15-cycle R/W access times; 4-cycle setup).
- Boot from 8-bit or 16-bit external flash memory The 8-bit flash boot routine located in boot ROM memory space is set up using asynchronous memory bank 0. For ADSP-BF539F processors, if FCE is connected to AMSO, then the on-chip flash is booted. All configuration settings are set for the slowest device possible (3-cycle hold time; 15-cycle R/W access times; 4-cycle setup).
- Boot from SPI serial EEPROM/flash (8-, 16-, or 24-bit addressable, or Atmel AT45DB041, AT45DB081, or AT45DB161) connected to SPI0 The SPI0 port uses the PF2 output pin to select a single SPI EEPROM/flash device, submits a read command and successive address bytes (0x00) until a valid 8-, 16-, or 24-bit, or Atmel addressable device is detected, and begins clocking data into the beginning of the L1 instruction memory.
- Boot from SPI host device connected to SPI0 The Black-fin processor operates in SPI slave mode and is configured to receive the bytes of the .LDR file from an SPI host (master) agent. To hold off the host device from transmitting while the boot ROM is busy, the Blackfin processor asserts a GPIO pin, called host wait (HWAIT), to signal the host device not to send any more bytes until the flag is deasserted. The flag is chosen by the user and this information is transferred to the Blackfin processor via bits 10:5 of the FLAG header in the .LDR image.

For each of the boot modes, a 10-byte header is first read from an external memory device. The header specifies the number of bytes to be transferred and the memory destination address.

Multiple memory blocks can be loaded by any boot sequence. Once all blocks are loaded, program execution commences from the start of L1 instruction SRAM.

In addition, Bit 4 of the reset configuration register can be set by application code to bypass the normal boot sequence during a software reset. For this case, the processor jumps directly to the beginning of L1 instruction memory.

To augment the boot modes, a secondary software loader is provided that adds additional booting mechanisms. This secondary loader provides the ability to boot from 16-bit flash memory, fast flash, variable baud rate, and other sources. In all boot modes except bypass, program execution starts from on-chip L1 memory address 0xFFA0 0000.

INSTRUCTION SET DESCRIPTION

The Blackfin processor family assembly language instruction set employs an algebraic syntax designed for ease of coding and readability. The instructions have been specifically tuned to provide a flexible, densely encoded instruction set that compiles to a very small final memory size. The instruction set also provides fully featured multifunction instructions that allow the programmer to use many of the processor core resources in a single instruction. Coupled with many features more often seen on microcontrollers, this instruction set is very efficient when compiling C and C++ source code. In addition, the architecture supports both user (algorithm/application code) and supervisor (O/S kernel, device drivers, debuggers, ISRs) modes of operation, allowing multiple levels of access to core processor resources.

The assembly language, which takes advantage of the processor's unique architecture, offers the following advantages:

- Seamlessly integrated DSP/CPU features are optimized for both 8-bit and 16-bit operations.
- A multi-issue load/store modified Harvard architecture, which supports two 16-bit MAC or four 8-bit ALU plus two load/store plus two pointer updates per cycle.
- All registers, I/O, and memory are mapped into a unified 4G byte memory space, providing a simplified programming model.
- Microcontroller features, such as arbitrary bit and bit-field manipulation, insertion, and extraction; integer operations on 8-, 16-, and 32-bit data types; and separate user and supervisor stack pointers.
- Code density enhancements, which include intermixing of 16-bit and 32-bit instructions (no mode switching, no code segregation). Frequently used instructions are encoded in 16 bits.

DEVELOPMENT TOOLS

Analog Devices supports its processors with a complete line of software and hardware development tools, including integrated development environments (which include CrossCore® Embedded Studio and/or VisualDSP++®), evaluation products, emulators, and a wide variety of software add-ins.

Integrated Development Environments (IDEs)

For C/C++ software writing and editing, code generation, and debug support, Analog Devices offers two IDEs.

The newest IDE, CrossCore Embedded Studio, is based on the Eclipse™ framework. Supporting most Analog Devices processor families, it is the IDE of choice for future processors, including multicore devices. CrossCore Embedded Studio seamlessly integrates available software add-ins to support real time operating systems, file systems, TCP/IP stacks, USB stacks, algorithmic software modules, and evaluation hardware board support packages. For more information visit www.analog.com/cces.

The other Analog Devices IDE, VisualDSP++, supports processor families introduced prior to the release of CrossCore Embedded Studio. This IDE includes the Analog Devices VDK real time operating system and an open source TCP/IP stack. For more information visit www.analog.com/visualdsp. Note that VisualDSP++ will not support future Analog Devices processors.

EZ-KIT Lite Evaluation Board

For processor evaluation, Analog Devices provides wide range of EZ-KIT Lite[®] evaluation boards. Including the processor and key peripherals, the evaluation board also supports on-chip emulation capabilities and other evaluation and development features. Also available are various EZ-Extenders[®], which are daughter cards delivering additional specialized functionality, including audio and video processing. For more information visit www.analog.com and search on "ezkit" or "ezextender".

EZ-KIT Lite Evaluation Kits

For a cost-effective way to learn more about developing with Analog Devices processors, Analog Devices offer a range of EZ-KIT Lite evaluation kits. Each evaluation kit includes an EZ-KIT Lite evaluation board, directions for downloading an evaluation version of the available IDE(s), a USB cable, and a power supply. The USB controller on the EZ-KIT Lite board connects to the USB port of the user's PC, enabling the chosen IDE evaluation suite to emulate the on-board processor in-circuit. This permits the customer to download, execute, and debug programs for the EZ-KIT Lite system. It also supports in-circuit programming of the on-board Flash device to store user-specific boot code, enabling standalone operation. With the full version of Cross-Core Embedded Studio or VisualDSP++ installed (sold separately), engineers can develop software for supported EZ-KITs or any custom system utilizing supported Analog Devices processors.

Software Add-Ins for CrossCore Embedded Studio

Analog Devices offers software add-ins which seamlessly integrate with CrossCore Embedded Studio to extend its capabilities and reduce development time. Add-ins include board support packages for evaluation hardware, various middleware packages, and algorithmic modules. Documentation, help, configuration dialogs, and coding examples present in these add-ins are viewable through the CrossCore Embedded Studio IDE once the add-in is installed.

Board Support Packages for Evaluation Hardware

Software support for the EZ-KIT Lite evaluation boards and EZ-Extender daughter cards is provided by software add-ins called Board Support Packages (BSPs). The BSPs contain the required drivers, pertinent release notes, and select example code for the given evaluation hardware. A download link for a specific BSP is located on the web page for the associated EZ-KIT or EZ-Extender product. The link is found in the *Product Download* area of the product web page.

Middleware Packages

Analog Devices separately offers middleware add-ins such as real time operating systems, file systems, USB stacks, and TCP/IP stacks. For more information see the following web pages:

- www.analog.com/ucos3
- www.analog.com/ucfs
- · www.analog.com/ucusbd
- www.analog.com/lwip

Algorithmic Modules

To speed development, Analog Devices offers add-ins that perform popular audio and video processing algorithms. These are available for use with both CrossCore Embedded Studio and VisualDSP++. For more information visit www.analog.com and search on "Blackfin software modules" or "SHARC software modules".

Designing an Emulator-Compatible DSP Board (Target)

For embedded system test and debug, Analog Devices provides a family of emulators. On each JTAG DSP, Analog Devices supplies an IEEE 1149.1 JTAG Test Access Port (TAP). In-circuit emulation is facilitated by use of this JTAG interface. The emulator accesses the processor's internal features via the processor's TAP, allowing the developer to load code, set breakpoints, and view variables, memory, and registers. The processor must be halted to send data and commands, but once an operation is completed by the emulator, the DSP system is set to run at full speed with no impact on system timing. The emulators require the target board to include a header that supports connection of the DSP's JTAG port to the emulator.

For details on target board design issues including mechanical layout, single processor connections, signal buffering, signal termination, and emulator pod logic, see the Engineer-to-Engineer Note "Analog Devices JTAG Emulation Technical Reference" (EE-68) on the Analog Devices website (www.analog.com)—use site search on "EE-68." This document is updated regularly to keep pace with improvements to emulator support.

EXAMPLE CONNECTIONS AND LAYOUT CONSIDERATIONS

Figure 9 shows an example circuit connection of the ADSP-BF539/ADSP-BF539F to a MOST network. This diagram is intended as an example, and exact connections and recommended circuit values should be obtained from Analog Devices.

MXVR BOARD LAYOUT GUIDELINES

MLF pin

• Capacitors:

C1: 0.1 μ F (PPS type, 2% tolerance recommended) C2: 0.01 μ F (PPS type, 2% tolerance recommended)

Resistor

R1: 220 Ω (1% tolerance)

- The RC network connected to the MLF pin should be located physically close to the MLF pin on the board.
- The RC network should be wired up and connected to the MLF pin using wide traces.
- The capacitors in the RC network should be grounded to MXEGND.
- The RC network should be shielded using MXEGND traces.
- Avoid routing other switching signals near the RC network to avoid crosstalk.

MXI driven with external clock oscillator IC (recommended)

- MXI should be driven with the clock output of a 49.152 MHz or 45.1584 MHz clock oscillator IC.
- MXO should be left unconnected.
- Avoid routing other switching signals near the oscillator and clock output trace to avoid crosstalk. When not possible, shield traces with ground.

MXI/MXO with external crystal

- The crystal must be a 49.152 MHz or 45.1584 MHz fundamental mode crystal.
- The crystal and load capacitors should be placed physically close to the MXI and MXO pins on the board.
- The load capacitors should be grounded to MXEGND.
- The crystal and load capacitors should be wired up using wide traces.
- Board trace capacitance on each lead should not be more than 3 pF.
- Trace capacitance plus load capacitance should equal the load capacitance specification for the crystal.
- Avoid routing other switching signals near the crystal and components to avoid crosstalk. When not possible, shield traces and components with ground.

MXEGND-MXVR crystal oscillator and MXVR PLL ground

- Should be routed with wide traces or as ground plane.
- Should be tied together to other board grounds at only one point on the board.
- Avoid routing other switching signals near to MXEGND to avoid crosstalk.

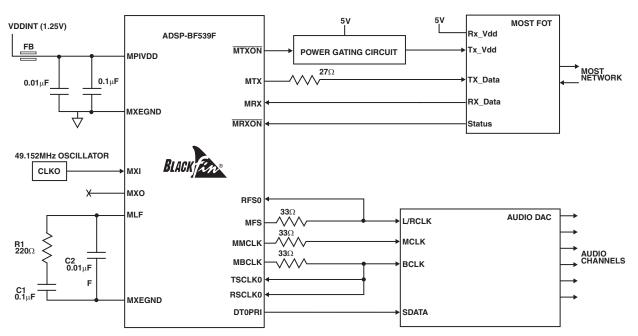


Figure 9. Example Connections of ADSP-BF539/ADSP-BF539F to MOST Network

MXEVDD-MXVR crystal oscillator 3.3 V power

- Should be routed with wide traces or as power plane.
- Locally bypass MXEVDD with 0.1 μF and 0.01 μF decoupling capacitors to MXEGND.
- Avoid routing other switching signals near to MXEVDD to avoid crosstalk.

MPIVDD-MXVR PLL 1.25 V power

- Should be routed with wide traces or as power plane.
- A ferrite bead should be placed between the 1.25 V $V_{\rm DDINT}$ power plane and the MPIVDD pin for noise isolation.
- Locally bypass MPIVDD with 0.1 μF and 0.01 μF decoupling capacitors to MXEGND.
- Avoid routing other switching signals near to MPIVDD to avoid crosstalk.

Fiber optic transceiver (FOT) connections

- The traces between the ADSP-BF539/ADSP-BF539F processor and the FOT should be kept as short as possible.
- The receive data trace connecting the FOT receive data output pin to the ADSP-BF539/ADSP-BF539F MRX input pin should not have a series termination resistor. The edge rate of the FOT receive data signal driven by the FOT is typically very slow, and further degradation of the edge rate is not desirable.

- The transmit data trace connecting the processor's MTX output pin to the FOT Transmit Data input pin should have a 27 W series termination resistor placed close to the ADSP-BF539/ADSP-BF539F MTX pin.
- The receive data trace and the transmit data trace between the processor and the FOT should not be routed close to each other in parallel over long distances to avoid crosstalk.

VOLTAGE REGULATOR LAYOUT GUIDELINES

Regulator external component placement, board routing, and bypass capacitors all have a significant effect on noise injected into the other analog circuits on-chip. The VROUT1-0 traces and voltage regulator external components should be considered as noise sources when doing board layout and should not be routed or placed near sensitive circuits or components on the board. All internal and I/O power supplies should be well bypassed with bypass capacitors placed as close to the ADSP-BF539/ADSP-BF539F as possible.

For further details on the on-chip voltage regulator and related board design guidelines, see the *Switching Regulator Design Considerations for ADSP-BF533 Blackfin Processors (EE-228)* applications note on the Analog Devices website (www.analog.com)—use site search on "EE-228".

ADDITIONAL INFORMATION

The following publications that describe the ADSP-BF539/ADSP-BF539F processors (and related processors) can be ordered from any Analog Devices sales office or accessed electronically on our website:

- Getting Started with Blackfin Processors
- ADSP-BF539 Blackfin Processor Hardware Reference
- ADSP-BF53x/ADSP-BF56x Blackfin Processor Programming Reference
- ADSP-BF539 Blackfin Processor Anomaly List

RELATED SIGNAL CHAINS

A *signal chain* is a series of signal-conditioning electronic components that receive input (data acquired from sampling either real-time phenomena or from stored data) in tandem, with the output of one portion of the chain supplying input to the next. Signal chains are often used in signal processing applications to gather and process data or to apply system controls based on analysis of real-time phenomena. For more information about this term and related topics, see the "signal chain" entry in Wikipedia or the Glossary of EE Terms on the Analog Devices website.

Analog Devices eases signal processing system development by providing signal processing components that are designed to work together well. A tool for viewing relationships between specific applications and related components is available on the www.analog.com website.

The Application Signal Chains page in the Circuits from the Lab™ site (http://www.analog.com/signalchains) provides:

- Graphical circuit block diagram presentation of signal chains for a variety of circuit types and applications
- Drill down links for components in each chain to selection guides and application information
- · Reference designs applying best practice design techniques

PIN DESCRIPTIONS

ADSP-BF539/ADSP-BF539F processor pin definitions are listed in Table 10.

All pins are three-stated during and immediately after reset, except the memory interface, asynchronous memory control, and synchronous memory control pins. These pins are all driven high, with the exception of CLKOUT, which toggles at the system clock rate. If \overline{BR} is active (whether or not \overline{RESET} is asserted), the memory pins are also three-stated. All unused I/O pins have their input buffers disabled with the exception of the

pins that need pull-ups or pull-downs, as noted in the table. During hibernate, all outputs are three-stated unless otherwise noted in Table 10.

In order to maintain maximum functionality and reduce package size and pin count, some pins have dual, multiplexed functionality. In cases where pin functionality is reconfigurable, the default state is shown in plain text, while alternate functionality is shown in italics.

Table 10. Pin Descriptions

| Pin Name | Туре | Description | Drive Type ¹ | | | |
|------------------------|-----------------|--|----------------------------|--|--|--|
| Memory Interface | l . | | II. | | | |
| ADDR19–1 | 0 | Address Bus for Async/Sync Access | Α | | | |
| DATA15-0 | I/O | Data Bus for Async/Sync Access | Α | | | |
| ABE1-0/SDQM1-0 | 0 | Byte Enables/Data Masks for Async/Sync Access | Α | | | |
| BR | I | Bus Request (This pin should be pulled high when not used.) | | | | |
| BG | 0 | Bus Grant | Α | | | |
| BGH | 0 | Bus Grant Hang | Α | | | |
| Asynchronous Memory C | ontrol | | | | | |
| AMS3-0 | 0 | Bank Select | Α | | | |
| ARDY | I | Hardware Ready Control (This pin should always be pulled low when not used.) | | | | |
| AOE | O Output Enable | | | | | |
| ĀRĒ | 0 | Read Enable | Α | | | |
| AWE | 0 | Write Enable | Α | | | |
| Flash Control | | | | | | |
| FCE | I | Flash Enable (This pin is internally connected to GND on the ADSP-BF539.) | | | | |
| FRESET | I | Flash Reset (This pin is internally connected to GND on the ADSP-BF539.) | | | | |
| Synchronous Memory Co. | ntrol | | 1 | | | |
| SRAS | 0 | Row Address Strobe | Α | | | |
| SCAS | 0 | Column Address Strobe | Α | | | |
| SWE | 0 | Write Enable | Α | | | |
| SCKE | 0 | Clock Enable (This pin must be pulled low through a 10 k Ω resistor if hibernate state is used and SDRAM contents need to be preserved during hibernate.) | Α | | | |
| CLKOUT | 0 | Clock Output | В | | | |
| SA10 | 0 | A10 Pin | Α | | | |
| SMS | О | Bank Select | Α | | | |
| Timers | • | <u> </u> | | | | |
| TMR0 | I/O | Timer 0 | С | | | |
| TMR1/PPI_FS1 | I/O | Timer 1/PPI Frame Sync1 | С | | | |
| TMR2/PPI_FS2 | I/O | Timer 2/PPI Frame Sync2 | C | | | |

Table 10. Pin Descriptions (Continued)

| Pin Name | Туре | Description | Driver Type ¹ |
|-------------------------------|-----------------|--|-----------------------------|
| Parallel Peripheral Interface | Port/GPIO | | |
| PF0/SPIOSS | I/O | Programmable Flag 0/SPI0 Slave Select Input | С |
| PF1/SPIOSEL1/TACLK | I/O | Programmable Flag 1/SPI0 Slave Select Enable 1/Timer Alternate Clock | C |
| PF2/SPI0SEL2 | I/O | Programmable Flag 2/SPI0 Slave Select Enable 2 | C |
| PF3/SPIOSEL3/PPI_FS3 | I/O | Programmable Flag 3/SPI0 Slave Select Enable 3/PPI Frame Sync 3 | C |
| PF4/SPI0SEL4/PPI15 | I/O | Programmable Flag 4/SPI0 Slave Select Enable 4/PPI 15 | C |
| PF5/SPI0SEL5/PPI14 | I/O | Programmable Flag 5/SPI0 Slave Select Enable 5/PPI 14 | С |
| PF6/SPIOSEL6/PPI13 | I/O | Programmable Flag 6/SPI0 Slave Select Enable 6/PPI 13 | C |
| PF7/SPIOSEL7/PPI12 | I/O | Programmable Flag 7/SPI0 Slave Select Enable 7/PPI 12 | C |
| PF8/PPI11 | I/O | Programmable Flag 8/PPI 11 | С |
| PF9/PPI10 | I/O | Programmable Flag 9/PPI 10 | C |
| PF10/ <i>PPI9</i> | I/O | Programmable Flag 10/PPI 9 | С |
| PF11/ <i>PPI8</i> | I/O | Programmable Flag 11/PPI 8 | С |
| PF12/PPI7 | I/O | Programmable Flag 12/ <i>PPI 7</i> | С |
| PF13/ <i>PPI6</i> | I/O | Programmable Flag 13/PPI 6 | С |
| PF14/ <i>PPI5</i> | I/O | Programmable Flag 14/ <i>PPI 5</i> | С |
| PF15/ <i>PPI4</i> | I/O | Programmable Flag 15/ <i>PPI 4</i> | С |
| PPI3-0 | I/O | PPI3-0 | С |
| PPI_CLK/TMRCLK | ı | PPI Clock/External Timer Reference | |
| Controller Area Network | | | |
| CANTX/PC0 | I/O 5 V | CAN Transmit/GPIO | С |
| CANRX/PC1 | I/OD 5 V | CAN Receive/GPIO | C^2 |
| Media Transceiver (MXVR)/ | General-Purpos | e I/O | |
| MTX/PC5 | I/O | MXVR Transmit Data/GPIO | С |
| MTXON/PC9 | I/O | MXVR Transmit FOT On/ <i>GPIO</i> | С |
| MRX/PC4 | I/OD 5 V | MXVR Receive Data/GPIO (This pin should be pulled low when not used.) | C^2 |
| MRXON | 15 V | MXVR FOT Receive On (This pin should be pulled high when not used.) | С |
| MXI | ı | MXVR Crystal Input (This pin should be pulled low when not used.) | |
| MXO | 0 | MXVR Crystal Output (This pin should be left unconnected when not used.) | |
| MLF | A I/O | MXVR Loop Filter (This pin should be pulled low when not used.) | |
| MMCLK/PC6 | I/O | MXVR Master Clock/ <i>GPIO</i> | С |
| MBCLK/PC7 | I/O | MXVR Bit Clock/ <i>GPIO</i> | С |
| MFS/PC8 | I/O | MXVR Frame Sync/ <i>GPIO</i> | С |
| GP | | GPIO PC4–9 Enable (This pin should be pulled low when MXVR is used.) | |
| 2-Wire Interface Ports | | a | |
| | and require a p | ull-up resistor. See version 2.1 of the I ² C specification for proper resistor values. | |
| SDA0 | I/O 5 V | TWI0 Serial Data | Е |
| SCL0 | I/O 5 V | TWI0 Serial Clock | E |
| SDA1 | I/O 5 V | TWI1 Serial Data | E |
| SCL1 | I/O 5 V | TWI1 Serial Clock | E |

Table 10. Pin Descriptions (Continued)

| Pin Name | Туре | Description | Driver Type ¹ |
|--------------|------|-------------------------------------|-----------------------------|
| Serial Port0 | | • | |
| RSCLK0 | I/O | SPORT0 Receive Serial Clock | D |
| RFS0 | I/O | SPORTO Receive Frame Sync | С |
| DROPRI | I | SPORTO Receive Data Primary | |
| DROSEC | I | SPORTO Receive Data Secondary | |
| TSCLK0 | I/O | SPORTO Transmit Serial Clock | D |
| TFS0 | I/O | SPORTO Transmit Frame Sync | С |
| DTOPRI | О | SPORTO Transmit Data Primary | С |
| DT0SEC | О | SPORTO Transmit Data Secondary | С |
| Serial Port1 | | • | |
| RSCLK1 | I/O | SPORT1 Receive Serial Clock | D |
| RFS1 | I/O | SPORT1 Receive Frame Sync | С |
| DR1PRI | I | SPORT1 Receive Data Primary | |
| DR1SEC | I | SPORT1 Receive Data Secondary | |
| TSCLK1 | I/O | SPORT1 Transmit Serial Clock | D |
| TFS1 | I/O | SPORT1 Transmit Frame Sync | С |
| DT1PRI | О | SPORT1 Transmit Data Primary | С |
| DT1SEC | О | SPORT1 Transmit Data Secondary | С |
| Serial Port2 | | • | |
| RSCLK2/PE0 | I/O | SPORT2 Receive Serial Clock/GPIO | D |
| RFS2/PE1 | I/O | SPORT2 Receive Frame Sync/GPIO | С |
| DR2PRI/PE2 | I/O | SPORT2 Receive Data Primary/GPIO | С |
| DR2SEC/PE3 | I/O | SPORT2 Receive Data Secondary/GPIO | С |
| TSCLK2/PE4 | I/O | SPORT2 Transmit Serial Clock/GPIO | D |
| TFS2/PE5 | I/O | SPORT2 Transmit Frame Sync/GPIO | С |
| DT2PRI /PE6 | I/O | SPORT2 Transmit Data Primary/GPIO | С |
| DT2SEC/PE7 | I/O | SPORT2 Transmit Data Secondary/GPIO | С |
| Serial Port3 | | • | |
| RSCLK3/PE8 | I/O | SPORT3 Receive Serial Clock/GPIO | D |
| RFS3/PE9 | I/O | SPORT3 Receive Frame Sync/GPIO | С |
| DR3PRI/PE10 | I/O | SPORT3 Receive Data Primary/GPIO | C |
| DR3SEC/PE11 | I/O | SPORT3 Receive Data Secondary/GPIO | C |
| TSCLK3/PE12 | I/O | SPORT3 Transmit Serial Clock/GPIO | D |
| TFS3/PE13 | I/O | SPORT3 Transmit Frame Sync/GPIO | С |
| DT3PRI /PE14 | I/O | SPORT3 Transmit Data Primary/GPIO | C |
| DT3SEC/PE15 | I/O | SPORT3 Transmit Data Secondary/GPIO | С |

Table 10. Pin Descriptions (Continued)

| Pin Name | Туре | Description | Driver Type ¹ |
|-----------------|----------|---|-----------------------------|
| SPI0 Port | • | | |
| MOSI0 | I/O | SPI0 Master Out Slave In | С |
| MISO0 | I/O | SPI0 Master In Slave Out (This pin should always be pulled high through a 4.7 k Ω resistor if booting via the SPI port.) | С |
| SCK0 | I/O | SPI0 Clock | D |
| SPI1 Port | <u>.</u> | | • |
| MOSI1/PD0 | I/O | SPI1 Master Out Slave In/GPIO | С |
| MISO1/PD1 | I/O | SPI1 Master In Slave Out/GPIO | С |
| SCK1/PD2 | I/O | SPI1 Clock/GPIO | D |
| SPI1SS/PD3 | I/O | SPI1 Slave Select Input/GPIO | D |
| SPI1SEL1/PD4 | I/O | SPI1 Slave Select Enable/GPIO | D |
| SPI2 Port | | | |
| MOSI2 /PD5 | I/O | SPI2 Master Out Slave In/GPIO | С |
| MISO2/PD6 | I/O | SPI2 Master In Slave Out/GPIO | С |
| SCK2/PD7 | I/O | SPI2 Clock/GPIO | D |
| SPI2SS/PD8 | I/O | SPI2 Slave Select Input/GPIO | D |
| SPI2SEL1/PD9 | I/O | SPI2 Slave Select Enable/GPIO | D |
| UARTO Port | | | II. |
| RX0 | I | UART Receive | |
| TX0 | О | UART Transmit | С |
| UART1 Port | | | |
| RX1/PD10 | I/O | UART1 Receive/GPIO | D |
| TX1/PD11 | I/O | UART1 Transmit/GPIO | D |
| UART2 Port | | | |
| RX2 /PD12 | I/O | UART2 Receive/GPIO | D |
| TX2/PD13 | I/O | UART2 Transmit/GPIO | D |
| Real-Time Clock | <u>.</u> | | • |
| RTXI | I | RTC Crystal Input (This pin should be pulled low when not used.) | |
| RTXO | О | RTC Crystal Output (Does not three-state in hibernate.) | |
| JTAG Port | <u>.</u> | | • |
| TCK | I | JTAG Clock | |
| TDO | О | JTAG Serial Data Out | С |
| TDI | I | JTAG Serial Data In | |
| TMS | I | JTAG Mode Select | |
| TRST | I | JTAG Reset (This pin should be pulled low if the JTAG port will not be used.) | |
| EMU | О | Emulation Output | С |
| Clock | <u>l</u> | | · L |
| CLKIN | I | Clock/Crystal Input | |
| XTAL | О | Crystal Output | |

Table 10. Pin Descriptions (Continued)

| Pin Name | Туре | Description | Driver Type ¹ | | | |
|-------------------|------|---|-----------------------------|--|--|--|
| Mode Controls | | <u> </u> | • | | | |
| RESET | I | Reset | | | | |
| NMI | I | Nonmaskable Interrupt (This pin should be pulled high when not used.) | | | | |
| BMODE1-0 | I | Boot Mode Strap (These pins must be pulled to the state required for the desired boot mode.) | | | | |
| Voltage Regulator | • | | • | | | |
| VROUT1-0 | 0 | External FET Drive 0 (These pins should be left unconnected when not used.) | | | | |
| Supplies | • | | • | | | |
| V_{DDEXT} | Р | I/O Power Supply | | | | |
| V_{DDINT} | Р | Internal Power Supply | | | | |
| V_{DDRTC} | Р | Real-Time Clock Power Supply (This pin should be connected to V_{DDEXT} when not used and should remain powered at all times.) | | | | |
| MPIVDD | Р | MXVR Internal Power Supply | | | | |
| MXEVDD | Р | MXVR External Power Supply | | | | |
| MXEGND | G | MXVR Ground | | | | |
| GND | G | Ground | | | | |

¹Refer to Figure 34 on Page 50 to Figure 43 on Page 51.

² This pin is 5 V-tolerant when configured as an input and an open-drain when configured as an output; therefore, only the VOL curves in Figure 38 on Page 50 and Figure 39 on Page 51 and the fall time curves in Figure 51 on Page 53 and Figure 52 on Page 53 apply when configured as an output.

SPECIFICATIONS

Component specifications are subject to change without notice.

OPERATING CONDITIONS

| Param | neter Conditions | | Min | Nom | Max | Unit |
|----------------------|---|--|------|------|-------|------|
| V _{DDINT} | Internal Supply Voltage ^{1, 2} | | 0.95 | 1.25 | 1.375 | V |
| V_{DDEXT} | External Supply Voltage ³ | | 2.7 | 3.3 | 3.6 | V |
| V_{DDRTC} | Real-Time Clock Power Supply Voltage | | 2.7 | 3.3 | 3.6 | V |
| V_{IH} | High Level Input Voltage ⁴ | $V_{DDEXT} = Maximum$ | 2.0 | | | V |
| V_{IH5V} | High Level Input Voltage⁵ | $V_{DDEXT} = Maximum$ | 2.0 | | | V |
| V_{IHCLKIN} | High Level Input Voltage ⁶ | $V_{DDEXT} = Maximum$ | 2.2 | | | V |
| V_{IL} | Low Level Input Voltage ^{4, 7} | $V_{DDEXT} = Minimum$ | | | +0.6 | V |
| V_{IL5V} | Low Level Input Voltage ⁵ | $V_{DDEXT} = Minimum$ | | | +0.8 | V |
| TJ | Junction Temperature | 316-Ball Chip Scale Ball Grid Array Package (CSP_BGA) | -40 | | +110 | °C |
| | | 533 MHz @ $T_{AMBIENT} = -40^{\circ}C$ to $+85^{\circ}C$ | | | | |

¹ Parameter value applies also to MPIVDD.

The following tables describe the voltage/frequency requirements for the ADSP-BF538/ADSP-BF538F processor clocks. Take care in selecting MSEL, SSEL, and CSEL ratios so as not to

exceed the maximum core clock (Table 11) and system clock (Table 13) specifications. Table 12 describes phase-locked loop operating conditions.

Table 11. Core Clock (CCLK) Requirements

| | | Internal Regulator | | |
|-------------------|--|--------------------|-----|------|
| Paramet | ter | Setting | Max | Unit |
| f_{CCLK} | CLK Frequency (V _{DDINT} = 1.2 V Minimum) | 1.25 V | 533 | MHz |
| f_{CCLK} | CLK Frequency (V _{DDINT} = 1.14 V Minimum) | 1.20 V | 500 | MHz |
| f_{CCLK} | CLK Frequency (V _{DDINT} = 1.045 V Minimum) | 1.10 V | 444 | MHz |
| f_{CCLK} | CLK Frequency (V _{DDINT} = 0.95 V Minimum) | 1.00 V | 400 | MHz |

Table 12. Phase-Locked Loop Operating Conditions

| Parameter | | Min | Max | Unit |
|-----------|---|-----|-----------------------|------|
| f_{VCO} | Voltage Controlled Oscillator (VCO) Frequency | 50 | Max f _{CCLK} | MHz |

Table 13. System Clock (SCLK) Requirements

| Parameter | 1 | Max | Unit | |
|-------------------|---|------------------|------|--|
| f _{SCLK} | CLKOUT/SCLK Frequency (V _{DDINT} ≥ 1.14 V) | 133 ² | MHz | |
| f_{SCLK} | CLKOUT/SCLK Frequency (V _{DDINT} < 1.14 V) | 100 | MHz | |

 $^{^{1}}$ t_{SCLK} (= 1/f_{SCLK}) must be greater than or equal to t_{CCLK}

 $^{^2}$ The regulator can generate $V_{\rm DDINT}$ at levels of 1.0 V to 1.2 V with -5% to +10% tolerance and 1.25 V with -4% to +10% tolerance.

³ Parameter value applies also to MXEVDD.

⁴The 3.3 V tolerant pins are capable of accepting up to 3.6 V maximum V_{IH} The following bidirectional pins are 3.3 V tolerant: DATA15−0, SCK2−0, MISO2−0, MOSI2−0, PF15−0, PP13−0, MTXON, MMCLK, MBCLK, MFS, MTX, SPI1SEL1, SPI2SS, SPI2SEL1, RX2−1, TX2−1, DT2PRI, DT2SEC, TSCLK3−0, DR2PRI, DR2SEC, DT3PRI, DT3SEC, RSCLK3−0, TFS3−0, RFS3−0, DR3PRI, DR3SEC, and TMR2−0. The following input-only pins are 3.3 V tolerant: RESET, RX0, TCK, TDI, TMS, TRST, ARDY, BMODE1−0, BR, DR0PRI, DR0SEC, DR1PRI, DR1SEC, NMI, PPI_CLK, RTXI, and GP.

⁵ The 5 V tolerant pins are capable of accepting up to 5.5 V maximum V_{II}. The following bidirectional pins are 5 V tolerant: SCL0, SCL1, SDA0, SDA1, and CANTX. The following input-only pins are 5 V tolerant: CANRX, MRX, MRXON.

⁶ Parameter value applies to the CLKIN and MXI input pins.

⁷ Parameter value applies to all input and bidirectional pins.

 $^{^{2}}$ Guaranteed to t_{SCLK} = 7.5 ns. See Table 26 on Page 36.

ELECTRICAL CHARACTERISTICS

| Parameter ¹ | | Test Conditions | Min | Тур | Max | Unit |
|----------------------------|--|--|-----|-----|---|------|
| V _{OH} | High Level Output Voltage ² | $V_{DDEXT} = +3.0 \text{ V}, I_{OH} = -0.5 \text{ mA}$ | 2.4 | | | ٧ |
| V_{oL} | Low Level Output Voltage ² | $V_{DDEXT} = 3.0 \text{ V}, I_{OL} = 2.0 \text{ mA}$ | | | 0.4 | V |
| I _{IH} | High Level Input Current ³ | V_{DDEXT} = Maximum, $V_{IN} = V_{DD}$ Maximum | | | 10.0 | μΑ |
| I _{IHP} | High Level Input Current JTAG ⁴ | $V_{DDEXT} = Maximum, V_{IN} = V_{DD} Maximum$ | | | 50.0 | μΑ |
| I _{IL} | Low Level Input Current ³ | $V_{DDEXT} = Maximum, V_{IN} = 0 V$ | | | 10.0 | μΑ |
| I _{OZH} | Three-State Leakage Current⁵ | $V_{DDEXT} = Maximum, V_{IN} = V_{DD} Maximum$ | | | 10.0 | μΑ |
| I _{OZL} | Three-State Leakage Current⁵ | $V_{DDEXT} = Maximum, V_{IN} = 0 V$ | | | 10.0 | μΑ |
| C_{IN} | Input Capacitance ^{6, 7} | $f_{CCLK} = 1 \text{ MHz}, T_{AMBIENT} = 25^{\circ}\text{C}, V_{IN} = 2.5 \text{ V}$ | | 4 | 8 | рF |
| I _{DDDEEPSLEEP} 8 | $V_{\tiny 	exttt{DDINT}}$ Current in Deep Sleep Mode | $V_{DDINT} = 1.0 \text{ V}, f_{CCLK} = 0 \text{ MHz}, T_{J} = 25^{\circ}\text{C}, \text{ ASF} = 0.00$ | | 7.5 | | mA |
| I _{DDSLEEP} | V _{DDINT} Current in Sleep Mode | $V_{DDINT} = 0.8 \text{ V}, T_{J} = 25^{\circ}\text{C}, SCLK = 25 \text{ MHz}$ | | | 10 | mA |
| I _{DD-TYP} | V _{DDINT} Current | $V_{DDINT} = 1.14 \text{ V}, f_{CCLK} = 400 \text{ MHz}, T_{J} = 25^{\circ}\text{C}$ | | 130 | | mA |
| I _{DD-TYP} | V _{DDINT} Current | $V_{DDINT} = 1.2 \text{ V}, f_{CCLK} = 500 \text{ MHz}, T_{J} = 25^{\circ}\text{C}$ | | 168 | | mA |
| I _{DD-TYP} | V _{DDINT} Current | $V_{DDINT} = 1.2 \text{ V}, f_{CCLK} = 533 \text{ MHz}, T_{J} = 25^{\circ}\text{C}$ | | 180 | | mA |
| I _{DDHIBERNATE} 8 | V _{DDEXT} Current in Hibernate State | $V_{DDEXT} = 3.6 \text{ V}$, CLKIN = 0 MHz, $T_{J} = Maximum$, voltage regulator off ($V_{DDINT} = 0 \text{ V}$) | | 50 | 100 | μΑ |
| I _{DDRTC} | V _{DDRTC} Current | $V_{DDRTC} = 3.3 \text{ V, } T_{J} = 25^{\circ}\text{C}$ | | 20 | | μΑ |
| I _{DDDEEPSLEEP} 8 | V _{DDINT} Current in Deep Sleep Mode | $f_{CCLK} = 0 MHz$ | | 6 | Table 14 | mA |
| I _{DDINT} 9 | V _{DDINT} Current | f _{cclk} > 0 MHz | | | $I_{DDDEEPSLEEP} + (Table 16 \times ASF)$ | mA |

 $^{^{\}rm 1}\,{\rm Specifications}$ subject to change without notice.

² Applies to output and bidirectional pins.

³ Applies to input pins except JTAG inputs.

 $^{^4}$ Applies to JTAG input pins (TCK, TDI, TMS, $\overline{\text{TRST}}$).

⁵ Applies to three-statable pins.

⁶ Applies to all signal pins.

⁷Guaranteed, but not tested.

 $^{^8 \,} See \, the \, ADSP\text{-}BF539 \, Black fin \, Processor \, Hardware \, Reference \, Manual \, for \, definitions \, of \, sleep, \, deep \, sleep, \, and \, hibernate \, operating \, modes.$

 $^{^9}$ See Table 15 for the list of $I_{\tiny DDINT}$ power vectors covered by various activity scaling factors (ASF).

System designers should refer to *Estimating Power for the ADSP-BF538/BF539 Blackfin Processors (EE-298)*, which provides detailed information for optimizing designs for lowest power. All topics discussed in this section are described in detail in EE-298. Total power dissipation has two components:

- 1. Static, including leakage current
- 2. Dynamic, due to transistor switching characteristics

Many operating conditions can also affect power dissipation, including temperature, voltage, operating frequency, and processor activity. Electrical Characteristics on Page 27 shows the

current dissipation for internal circuitry (V_{DDINT}). $I_{\text{DDDEEPSLEEP}}$ specifies static power dissipation as a function of voltage (V_{DDINT}) and temperature (see Table 14), and I_{DDINT} specifies the total power specification for the listed test conditions, including the dynamic component as a function of voltage (V_{DDINT}) and frequency (Table 16).

The dynamic component is also subject to an Activity Scaling Factor (ASF) which represents application code running on the processor (Table 15).

Table 14. Static Current (mA)¹

| | V _{DDINT} (V) | | | | | | | | | | | | |
|---------|------------------------|--------|--------|--------|--------|--------|--------|--------|--------|--------|--------|--------|---------|
| (°C) رT | 0.80 V | 0.85 V | 0.90 V | 0.95 V | 1.00 V | 1.05 V | 1.10 V | 1.15 V | 1.20 V | 1.25 V | 1.30 V | 1.32 V | 1.375 V |
| -40 | 6.4 | 7.7 | 8.8 | 10.4 | 12.0 | 14.0 | 16.1 | 18.9 | 21.9 | 25.2 | 28.7 | 30.6 | 35.9 |
| -25 | 9.2 | 10.9 | 12.5 | 14.5 | 16.7 | 19.3 | 22.1 | 25.6 | 29.5 | 33.7 | 38.1 | 40.5 | 47.2 |
| 0 | 16.8 | 18.9 | 21.5 | 24.4 | 27.7 | 31.7 | 35.8 | 40.5 | 45.8 | 51.6 | 58.2 | 61.0 | 69.8 |
| 25 | 32.9 | 37.2 | 41.4 | 46.2 | 51.8 | 57.4 | 64.2 | 72.3 | 80.0 | 89.3 | 98.9 | 103.3 | 116.4 |
| 40 | 48.4 | 54.8 | 60.5 | 67.1 | 74.7 | 82.9 | 91.6 | 101.5 | 112.4 | 123.2 | 136.2 | 142.0 | 158.7 |
| 55 | 71.2 | 78.6 | 86.5 | 95.8 | 104.9 | 115.7 | 127.1 | 139.8 | 153.6 | 168.0 | 183.7 | 191.0 | 211.8 |
| 70 | 102.3 | 112.2 | 122.1 | 133.5 | 146.1 | 159.2 | 173.9 | 189.8 | 206.7 | 225.5 | 245.6 | 254.1 | 279.6 |
| 85 | 140.7 | 153.0 | 167.0 | 182.5 | 198.0 | 216.0 | 234.3 | 254.0 | 276.0 | 299.1 | 324.3 | 334.8 | 366.6 |
| 100 | 190.6 | 207.1 | 224.6 | 244.0 | 265.6 | 285.7 | 309.0 | 333.7 | 360.0 | 387.8 | 417.3 | 431.1 | 469.3 |
| 105 | 210.2 | 228.1 | 245.1 | 265.6 | 285.8 | 309.2 | 334.0 | 360.1 | 385.6 | 417.2 | 448.0 | 461.5 | 501.1 |

 $^{^{1}\,\}text{Values}$ are guaranteed maximum $I_{\text{\tiny DDDEEPSLEEP}}$ specifications.

Table 15. Activity Scaling Factors

| I _{DDINT} Power Vector ¹ | Activity Scaling Factor (ASF) ² |
|--|--|
| I _{DD-PEAK-MXVR} | 1.36 |
| I _{DD-HIGH-MXVR} | 1.32 |
| I _{DD-PEAK} | 1.30 |
| I _{DD-HIGH} | 1.28 |
| I _{DD-TYP-MXVR} | 1.07 |
| I _{DD-TYP} | 1.00 |
| I _{DD-APP-MXVR} | 0.92 |
| I _{DD-APP} | 0.88 |
| I _{DD-NOP-MXVR} | 0.76 |
| I _{DD-NOP} | 0.74 |
| I _{DD-IDLE-MXVR} | 0.50 |
| I _{DD-IDLE} | 0.48 |

 $^{^{\}rm 1}\,{\rm See}$ EE-298 for power vector definitions.

 $^{^2\,\}mbox{All}$ ASF values determined using a 10:1 CCLK:SCLK ratio.

Table 16. Dynamic Current (mA, with ASF = 1.0)¹

| Frequency | $V_{ m DDINT}$ | | | | | | | | | |
|-----------|----------------|--------|--------|--------|--------|--------|--------|--------|--------|---------|
| (MHz) | 0.95 V | 1.00 V | 1.05 V | 1.10 V | 1.15 V | 1.20 V | 1.25 V | 1.30 V | 1.32 V | 1.375 V |
| 50 | 17.5 | 19.1 | 20.5 | 22.0 | 23.5 | 25.4 | 27.1 | 29.1 | 29.7 | 31.6 |
| 100 | 30.1 | 32.3 | 34.4 | 37.0 | 39.2 | 41.7 | 44.3 | 46.4 | 47.6 | 50.3 |
| 200 | 54.8 | 58.4 | 61.8 | 65.6 | 69.7 | 74.3 | 76.2 | 82.2 | 83.4 | 87.8 |
| 250 | 66.8 | 71.2 | 75.7 | 79.9 | 84.5 | 89.8 | 94.2 | 99.4 | 101.2 | 106.5 |
| 300 | 79.3 | 84.5 | 89.0 | 94.7 | 100.0 | 105.5 | 111.6 | 116.8 | 119.3 | 125.5 |
| 375 | 97.9 | 103.9 | 109.9 | 116.5 | 122.2 | 129.7 | 136.0 | 142.9 | 145.9 | 153.6 |
| 400 | 103.8 | 110.3 | 116.9 | 123.7 | 130.0 | 137.5 | 144.2 | 151.2 | 154.5 | 162.4 |
| 425 | N/A | 116.6 | 123.7 | 130.9 | 137.2 | 144.7 | 152.7 | 159.9 | 163.3 | 171.8 |
| 475 | N/A | N/A | N/A | 145.0 | 151.8 | 161.4 | 169.4 | 177.8 | 181.1 | 190.4 |
| 500 | N/A | N/A | N/A | N/A | 159.9 | 168.9 | 177.8 | 186.3 | 190.0 | 199.6 |
| 533 | N/A | N/A | N/A | N/A | N/A | 179.8 | 188.9 | 198.8 | 202.2 | 212.5 |

¹The values are not guaranteed as standalone maximum specifications, they must be combined with static current per the equations of Electrical Characteristics on Page 27.

ABSOLUTE MAXIMUM RATINGS

Stresses greater than those listed in Table 17 may cause permanent damage to the device. These are stress ratings only. Functional operation of the device at these or any other conditions greater than those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Table 17. Absolute Maximum Ratings

| Parameter | Rating |
|---|--|
| Internal (Core) Supply Voltage (V _{DDINT}) ¹ | -0.3 V to +1.4 V |
| External (I/O) Supply Voltage (V _{DDEXT}) ² | -0.3 V to +3.8 V |
| Input Voltage ^{3, 4} | -0.5 V to +3.8 V |
| Input Voltage ^{4, 5} | -0.5 V to +5.5 V |
| Output Voltage Swing | $-0.5 \text{ V to V}_{\text{DDEXT}} + 0.5 \text{ V}$ |
| Junction Temperature While Biased | +125°C |
| Storage Temperature Range | -65°C to +150°C |

¹ Parameter value applies also to MPIVDD.

Table 18. Maximum Duty Cycle for Input Transient Voltage¹

| V _{IN} Min (V) ² | V _{IN} Max (V) ² | Maximum Duty Cycle ³ |
|--------------------------------------|--------------------------------------|---------------------------------|
| -0.50 | +3.80 | 100% |
| -0.70 | +4.00 | 40% |
| -0.80 | +4.10 | 25% |
| -0.90 | +4.20 | 15% |
| -1.00 | +4.30 | 10% |

¹ Applies to all signal pins with the exception of CLKIN, MXI, MXO, MLF, VROUT1–0, XTAL, RTXI, and RTXO.

ESD SENSITIVITY



ESD (electrostatic discharge) sensitive device.

Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

PACKAGE INFORMATION

The information presented in Figure 10 and Table 19 provides information about how to read the package brand and relate it to specific product features. For a complete listing of product offerings, see the Ordering Guide on Page 60.



Figure 10. Product Information on Package

Table 19. Package Brand Information¹

| Brand Key | Field Description |
|-----------|----------------------------|
| t | Temperature Range |
| рр | Package Type |
| Z | RoHS Compliant Part |
| ccc | See Ordering Guide |
| vvvvv.xw | Assembly Lot Code |
| n.n | Silicon Revision |
| # | RoHS Compliant Designation |
| yyww | Date Code |

 $^{^{\}rm l}$ Non Automotive only. For branding information specific to Automotive products, contact Analog Devices Inc.

 $^{^2\,\}mbox{Parameter}$ value applies also to MXEVDD and $\mbox{V}_{\mbox{\scriptsize DDRTC}}.$

³ Applies to 100% transient duty cycle. For other duty cycles, see Table 18.

 $^{^4}$ Applies only when V_{DDEXT} is within specifications. When V_{DDEXT} is outside specifications, the range is $V_{DDEXT}\pm0.2~V.$

⁵ Applies to pins designated as 5 V tolerant only.

² The individual values cannot be combined for analysis of a single instance of overshoot or undershoot. The worst case observed value must fall within one of the voltages specified and the total duration of the overshoot or undershoot (exceeding the 100% case) must be less than or equal to the corresponding duty cycle.

³ Duty cycle refers to the percentage of time the signal exceeds the value for the 100% case. The is equivalent to the measured duration of a single instance of overshoot or undershoot as a percentage of the period of occurrence.

TIMING SPECIFICATIONS

Component specifications are subject to change with PCN notice.

Clock and Reset Timing

Table 20 and Figure 11 describe clock and reset operations. Per Absolute Maximum Ratings on Page 30, combinations of CLKIN and clock multipliers must not select core/peripheral clocks that exceed maximum operating conditions.

Table 20. Clock and Reset Timing

| Parameter | | Min | Max | Unit |
|---------------------|---|----------------------|---------------------|------|
| Timing Requ | irements | | | |
| f_{CKIN} | CLKIN Frequency (Commercial/Industrial Models) 1,2,3,4 | 10 | 50 | MHz |
| | CLKIN Frequency (Automotive Models) 1, 2, 3, 4 | 10 | 50 | MHz |
| t _{CKINL} | CLKIN Low Pulse ¹ | 8 | | ns |
| t _{CKINH} | CLKIN High Pulse ¹ | 8 | | ns |
| t_{WRST} | RESET Asserted Pulse Width Low ⁵ | $11 \times t_{CKIN}$ | | ns |
| t _{NOBOOT} | RESET Deassertion to First External Access Delay ⁶ | $3 \times t_{CKIN}$ | $5 \times t_{CKIN}$ | ns |

¹ Applies to PLL bypass mode and PLL nonbypass mode.

 $^{^6}$ Applies when processor is configured in No Boot Mode (BMODE2-0 = b#000).

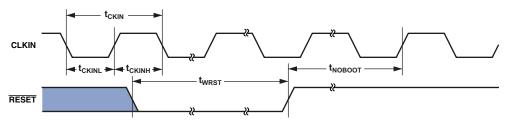
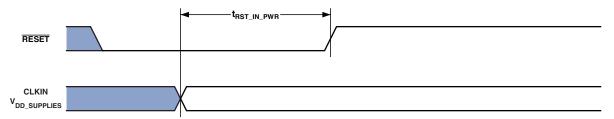


Figure 11. Clock and Reset Timing

Table 21. Power-Up Reset Timing

| Parameter | Min | Max | Unit |
|--------------|------------------------------|-----|------|
| Timing Requi | 3500 × t _{CKIN} | | ns |



In Figure 12, $V_{DD_SUPPLIES}$ is V_{DDINT} , V_{DDEXT} , V_{DDRTC} , MPIVDD, MXEVDD

Figure 12. Power-Up Reset Timing

² Combinations of the CLKIN frequency and the PLL clock multiplier must not exceed the allowed f_{VCO} , f_{CCLK} , and f_{SCLK} settings discussed in Table 12 on Page 26 through Table 16 on Page 29.

 $^{^3\,} The\ t_{CKIN}\ period$ (see Figure 11) equals $1/f_{CKIN}.$

⁴ If the DF bit in the PLL_CTL register is set, the minimum f_{CKIN} specification is 24 MHz for commercial/industrial models and 28 MHz for automotive models.

⁵ Applies after power-up sequence is complete. See Table 21 and Figure 12 for power-up reset timing.

Asynchronous Memory Read Cycle Timing

Table 22 and Table 23 on Page 33 and Figure 13 and Figure 14 on Page 33 describe asynchronous memory read cycle operations for synchronous and for asynchronous ARDY.

Table 22. Asynchronous Memory Read Cycle Timing with Synchronous ARDY

| Parameter | | Min | Max | Unit |
|-------------|--|-----|-----|------|
| Timing Requ | uirements | | | |
| t_{SDAT} | DATA15-0 Setup Before CLKOUT | 2.1 | | ns |
| t_{HDAT} | DATA15-0 Hold After CLKOUT | 0.8 | | ns |
| t_{SARDY} | ARDY Setup Before the Falling Edge of CLKOUT | 4.0 | | ns |
| t_{HARDY} | ARDY Hold After the Falling Edge of CLKOUT | 0.0 | | ns |
| Switching C | haracteristics | | | |
| t_{DO} | Output Delay After CLKOUT ¹ | | 6.0 | ns |
| t_{HO} | Output Hold After CLKOUT ¹ | 0.8 | | ns |

 $^{^{1}}$ Output pins include $\overline{AMS3-0}$, $\overline{ABE1-0}$, ADDR19-1, \overline{AOE} , \overline{ARE} .

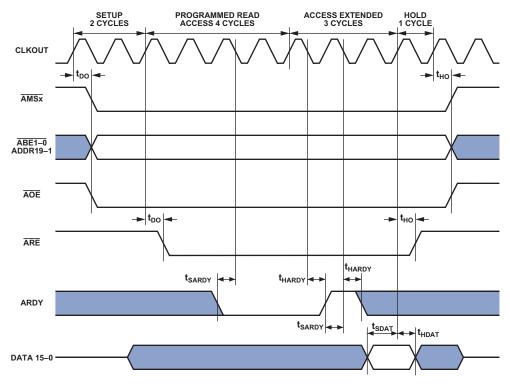


Figure 13. Asynchronous Memory Read Cycle Timing with Synchronous ARDY

Table 23. Asynchronous Memory Read Cycle Timing with Asynchronous ARDY

| Parameter | | Min | Max | Unit |
|-------------------|--|-----|--------------------------------|------|
| Timing Requ | uirements | | | |
| t _{SDAT} | DATA15-0 Setup Before CLKOUT | 2.1 | | ns |
| t_{HDAT} | DATA15-0 Hold After CLKOUT | 0.8 | | ns |
| t _{DANR} | ARDY Negated Delay from AMSx Asserted1 | | $(S + RA - 2) \times t_{SCLK}$ | ns |
| t _{HAA} | ARDY Asserted Hold After ARE Negated | 0.0 | | ns |
| Switching C | haracteristics | | | |
| t_{DO} | Output Delay After CLKOUT ² | | 6.0 | ns |
| t_{HO} | Output Hold After CLKOUT ² | 0.8 | | ns |

 $^{^{1}}$ S = number of programmed setup cycles, RA = number of programmed read access cycles.

² Output pins include $\overline{AMS3-0}$, $\overline{ABE1-0}$, ADDR19-1, \overline{AOE} , \overline{ARE} .

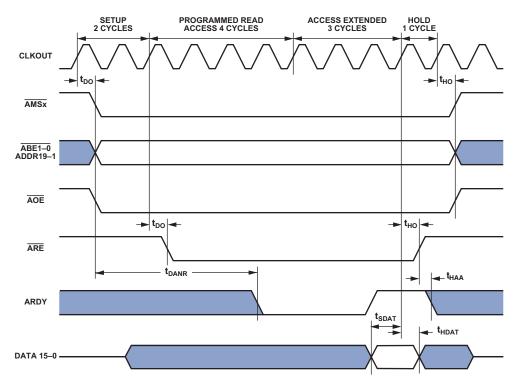


Figure 14. Asynchronous Memory Read Cycle Timing with Asynchronous ARDY

Asynchronous Memory Write Cycle Timing

Table 24 and Table 25 and Figure 15 and Figure 16 describe asynchronous memory write cycle operations for synchronous and for asynchronous ARDY.

Table 24. Asynchronous Memory Write Cycle Timing with Synchronous ARDY

| Parameter | | Min | Max | Unit |
|--------------------|--|-----|-----|------|
| Timing Requ | uirements | | | |
| t_{SARDY} | ARDY Setup Before the Falling Edge of CLKOUT | 4.0 | | ns |
| t _{HARDY} | ARDY Hold After the Falling Edge of CLKOUT | 0.0 | | ns |
| Switching Co | haracteristics | | | |
| t_{DDAT} | DATA15-0 Disable After CLKOUT | | 6.0 | ns |
| t _{ENDAT} | DATA15-0 Enable After CLKOUT | 1.0 | | ns |
| t_{DO} | Output Delay After CLKOUT ¹ | | 6.0 | ns |
| t_{HO} | Output Hold After CLKOUT ¹ | 0.8 | | ns |

¹Output pins include AMS3-0, ABE1-0, ADDR19-1, DATA15-0, AOE, AWE.

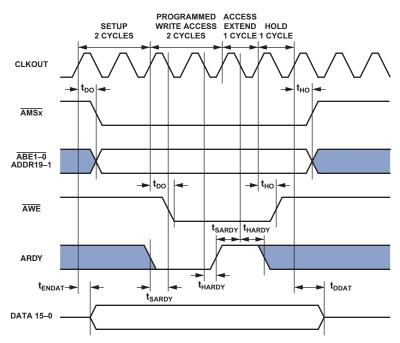


Figure 15. Asynchronous Memory Write Cycle Timing with Synchronous ARDY

Table 25. Asynchronous Memory Write Cycle Timing with Asynchronous ARDY

| Parameter | | Min | Max | Unit |
|--------------------|--|-----|--------------------------------|------|
| Timing Requ | uirements | | | |
| t _{DANR} | ARDY Negated Delay from AMSx Asserted ¹ | | $(S + WA - 2) \times t_{SCLK}$ | ns |
| t_{HAA} | ARDY Asserted Hold After ARE Negated | 0.0 | | ns |
| Switching C | haracteristics | | | |
| t_{DDAT} | DATA15-0 Disable After CLKOUT | | 6.0 | ns |
| t _{ENDAT} | DATA15-0 Enable After CLKOUT | 1.0 | | ns |
| t_{DO} | Output Delay After CLKOUT ² | | 6.0 | ns |
| t_{HO} | Output Hold After CLKOUT ² | 0.8 | | ns |

 $^{^{1}}$ S = Number of programmed setup cycles, WA = Number of programmed write access cycles.

²Output pins include AMS3-0, ABE1-0, ADDR19-1, DATA15-0, AOE, AWE.

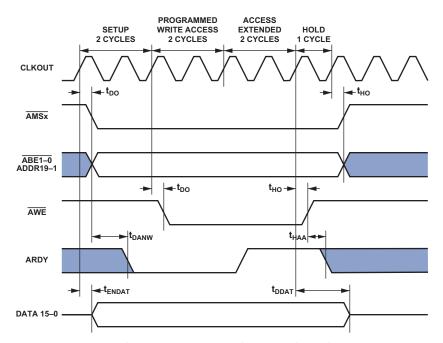


Figure 16. Asynchronous Memory Write Cycle Timing with Asynchronous ARDY

SDRAM Interface Timing

Table 26. SDRAM Interface Timing

| Paramet | ter | Min | Max | Unit |
|---------------------|---|-----|-----|------|
| Timing R | equirements | | | |
| t_{SSDAT} | DATA Setup Before CLKOUT | 2.1 | | ns |
| t _{HSDAT} | DATA Hold After CLKOUT | 0.8 | | ns |
| Switchin | g Characteristics | | | |
| t _{SCLK} | CLKOUT Period ¹ | 7.5 | | ns |
| t _{SCLKH} | CLKOUT Width High | 2.5 | | ns |
| t _{SCLKL} | CLKOUT Width Low | 2.5 | | ns |
| t _{DCAD} | Command, ADDR, Data Delay After CLKOUT ² | | 6.0 | ns |
| t _{HCAD} | Command, ADDR, Data Hold After CLKOUT ² | 0.8 | | ns |
| t _{DSDAT} | Data Disable After CLKOUT | | 6.0 | ns |
| t _{ENSDAT} | Data Enable After CLKOUT | 1.0 | | ns |

 $^{^{1}}$ SDRAM timing for T_{JUNCTION} = 125°C is limited to 100 MHz. 2 Command pins include: $\overline{SRAS}, \overline{SCAS}, \overline{SWE}, SDQM, \overline{SMS}, SA10, SCKE.$

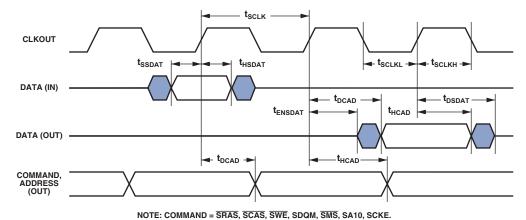


Figure 17. SDRAM Interface Timing

External Port Bus Request and Grant Cycle Timing

Table 27 and Table 28 and Figure 18 and Figure 19 describe external port bus request and grant cycle operations for synchronous and for asynchronous \overline{BR} .

Table 27. External Port Bus Request and Grant Cycle Timing with Synchronous \overline{BR}

| Paramete | r | Min | Max | Unit |
|-------------|---|-----|-----|------|
| Timing Red | uirements | | | |
| t_{BS} | BR Setup to Falling Edge of CLKOUT | 4.6 | | ns |
| t_{BH} | Falling Edge of CLKOUT to BR Deasserted Hold Time | 1.0 | | ns |
| Switching (| Characteristics | | | |
| t_{SD} | CLKOUT Low to AMSx, Address, and ARE/AWE Disable | | 4.5 | ns |
| t_SE | CLKOUT Low to AMSx, Address, and ARE/AWE Enable | | 4.5 | ns |
| t_{DBG} | CLKOUT High to BG High Setup | | 4.0 | ns |
| t_{EBG} | CLKOUT High to $\overline{\rm BG}$ Deasserted Hold Time | | 4.0 | ns |
| t_{DBH} | CLKOUT High to BGH High Setup | | 4.0 | ns |
| t_{EBH} | CLKOUT High to BGH Deasserted Hold Time | | 4.0 | ns |

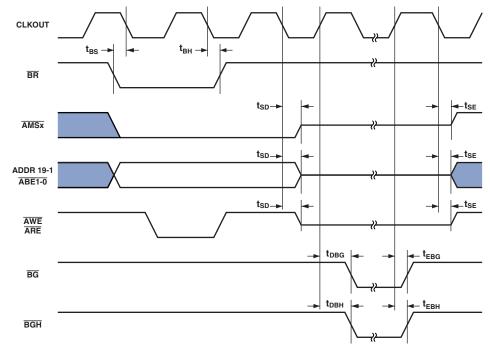


Figure 18. External Port Bus Request and Grant Cycle Timing with Synchronous \overline{BR}

Table 28. External Port Bus Request and Grant Cycle Timing with Asynchronous \overline{BR}

| Paramete | r | Min | Max | Unit |
|------------------|--|---------------------|-----|------|
| Timing Req | uirement | | | |
| t_{WBR} | BR Pulse Width | $2 \times t_{SCLK}$ | | ns |
| Switching (| Characteristics | | | |
| t_{SD} | CLKOUT Low to AMSx, Address, and ARE/AWE Disable | | 4.5 | ns |
| t_SE | CLKOUT Low to AMSx, Address, and ARE/AWE Enable | | 4.5 | ns |
| t_{DBG} | CLKOUT High to BG High Setup | | 3.6 | ns |
| t_{EBG} | CLKOUT High to $\overline{\text{BG}}$ Deasserted Hold Time | | 3.6 | ns |
| t_{DBH} | CLKOUT High to BGH High Setup | | 3.6 | ns |
| t _{EBH} | CLKOUT High to BGH Deasserted Hold Time | | 3.6 | ns |

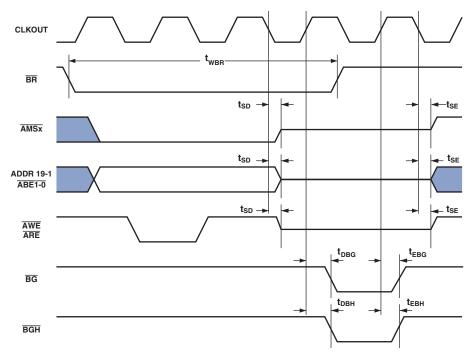


Figure 19. External Port Bus Request and Grant Cycle Timing with Asynchronous $\overline{\it BR}$

Parallel Peripheral Interface Timing

Table 29 and Figure 20, Figure 21, Figure 22, and Figure 23 describe Parallel Peripheral Interface operations.

Table 29. Parallel Peripheral Interface Timing

| Parameter | | Min | Max | Unit |
|---------------------|--|------|------|------|
| Timing Requ | irements | | | |
| t _{PCLKW} | PPI_CLK Width | 6.0 | | ns |
| t_{PCLK} | PPI_CLK Period ¹ | 15.0 | | ns |
| t _{SFSPE} | External Frame Sync Setup Before PPI_CLK | 5.0 | | ns |
| t _{HFSPE} | External Frame Sync Hold After PPI_CLK | 1.0 | | ns |
| t _{SDRPE} | Receive Data Setup Before PPI_CLK | 2.0 | | ns |
| t _{HDRPE} | Receive Data Hold After PPI_CLK | 4.0 | | ns |
| Switching Cl | haracteristics—GP Output and Frame Capture Modes | | | |
| t_{DFSPE} | Internal Frame Sync Delay After PPI_CLK | | 10.0 | ns |
| t _{HOFSPE} | Internal Frame Sync Hold After PPI_CLK | 0.0 | | ns |
| t _{DDTPE} | Transmit Data Delay After PPI_CLK | | 10.0 | ns |
| t_{HDTPE} | Transmit Data Hold After PPI_CLK | 0.0 | | ns |

 $^{^{1}\,\}mathrm{PPI_CLK}$ frequency cannot exceed f_{SCLK}/2.

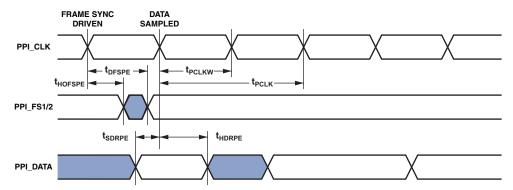


Figure 20. PPI GP Rx Mode with Internal Frame Sync Timing

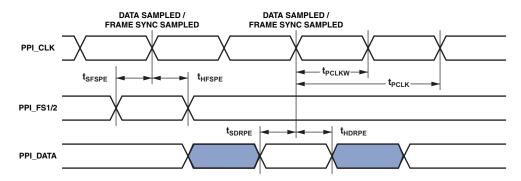


Figure 21. PPI GP Rx Mode with External Frame Sync Timing

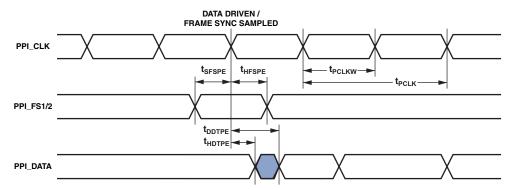


Figure 22. PPI GP Tx Mode with External Frame Sync Timing

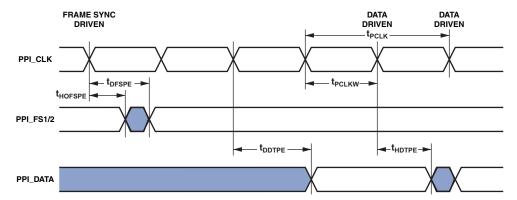


Figure 23. PPI GP Tx Mode with Internal Frame Sync Timing

Serial Ports Timing

Table 30 through Table 33 and Figure 24 through Figure 27 describe Serial Port operations.

Table 30. Serial Ports—External Clock

| Parameter | | Min | Max | Unit |
|---------------------|--|-----------------------|------|------|
| Timing Requ | irements | | | |
| t _{SFSE} | TFSx/RFSx Setup Before TSCLKx/RSCLKx (Externally Generated TFSx/RFSx) ¹ | 3.0 | | ns |
| t_{HFSE} | TFSx/RFSx Hold After TSCLKx/RSCLKx (Externally Generated TFSx/RFSx) ¹ | 3.0 | | ns |
| t _{SDRE} | Receive Data Setup Before RSCLKx ¹ | 3.0 | | ns |
| t_{HDRE} | Receive Data Hold After RSCLKx ¹ | 3.0 | | ns |
| t _{SCLKEW} | TSCLKx/RSCLKx Width | 4.5 | | ns |
| t _{SCLKE} | TSCLKx/RSCLKx Period | 15.0 | | ns |
| t _{SUDTE} | Start-Up Delay From SPORT Enable To First External TFSx ² | $4.0 \times t_{SCLH}$ | Œ | ns |
| t _{SUDRE} | Start-Up Delay From SPORT Enable To First External RFSx ² | $4.0 \times t_{SCLH}$ | Œ | ns |
| Switching Cl | naracteristics | | | |
| t _{DFSE} | TFSx/RFSx Delay After TSCLKx/RSCLKx (Internally Generated TFSx/RFSx) ³ | | 10.0 | ns |
| t _{HOFSE} | TFSx/RFSx Hold After TSCLKx/RSCLKx (Internally Generated TFSx/RFSx) ³ | 0.0 | | ns |
| t _{DDTE} | Transmit Data Delay After TSCLKx ³ | | 10.0 | ns |
| t_{HDTE} | Transmit Data Hold After TSCLKx ³ | 0.0 | | ns |

¹ Referenced to sample edge.

Table 31. Serial Ports—Internal Clock

| Parameter | | Min | Max | Unit |
|---------------------|--|------|-----|------|
| Timing Requ | irements | | | |
| t _{SFSI} | TFSx/RFSx Setup Before TSCLKx/RSCLKx (Externally Generated TFSx/RFSx) ¹ | 9.0 | | ns |
| t _{HFSI} | TFSx/RFSx Hold After TSCLKx/RSCLKx (Externally Generated TFSx/RFSx) ¹ | -1.5 | | ns |
| t _{SDRI} | Receive Data Setup Before RSCLKx ¹ | 9.0 | | ns |
| t _{HDRI} | Receive Data Hold After RSCLKx ¹ | -1.5 | | ns |
| Switching C | haracteristics | | | |
| t _{DFSI} | TFSx/RFSx Delay After TSCLKx/RSCLKx (Internally Generated TFSx/RFSx) ² | | 3.5 | ns |
| t _{HOFSI} | TFSx/RFSx Hold After TSCLKx/RSCLKx (Internally Generated TFSx/RFSx) ² | -1.0 | | ns |
| t _{DDTI} | Transmit Data Delay After TSCLKx ² | | 3.0 | ns |
| t_{HDTI} | Transmit Data Hold After TSCLKx ² | -2.0 | | ns |
| t _{SCLKIW} | TSCLKx/RSCLKx Width | 4.5 | | ns |

¹ Referenced to sample edge.

² Verified in design but untested. After being enabled, the serial port requires external clock pulses—before the first external frame sync edge—to initialize the serial port.

³ Referenced to drive edge.

 $^{^2}$ Referenced to drive edge.

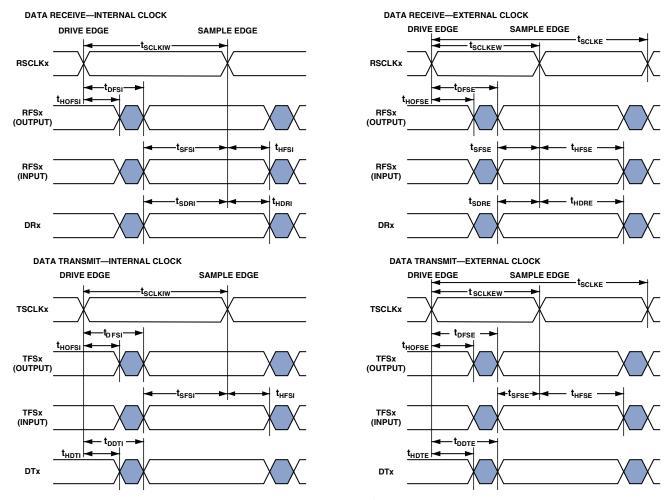


Figure 24. Serial Ports

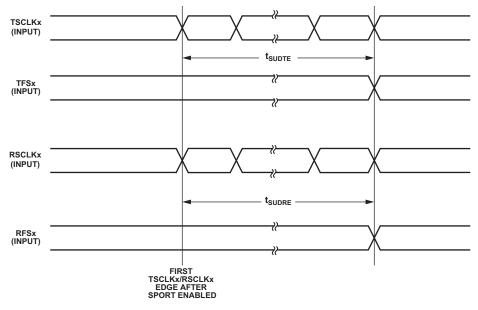


Figure 25. Serial Port Start Up with External Clock and Frame Sync

Table 32. Serial Ports—Enable and Three-State

| Parameter | • | Min | Max | Unit |
|--------------------|--|------|------|------|
| Switching C | Characteristics | | | |
| t _{DTENE} | Data Enable Delay from External TSCLKx1 | 0 | | ns |
| t _{DDTTE} | Data Disable Delay from External TSCLKx1, 2, 3 | | 10.0 | ns |
| t _{DTENI} | Data Enable Delay from Internal TSCLKx1 | -2.0 | | ns |
| t _{DDTTI} | Data Disable Delay from Internal TSCLKx ^{1, 2, 3} | | 3.0 | ns |

¹ Referenced to drive edge.

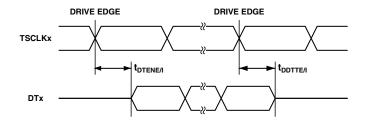


Figure 26. Enable and Three-State

Table 33. External Late Frame Sync

| Parameter | | Min | Max | Unit |
|----------------------|---|-----|------|------|
| Switching Ch | aracteristics | | | |
| t _{DDTLFSE} | Data Delay from Late External TFSx or External RFSx in multichannel mode, MFD = $0^{1,2}$ | | 10.0 | ns |
| t _{DTENLFS} | Data Enable from Late FS or multichannel mode, MFD = $0^{1,2}$ | 0 | | ns |

 $^{^{1}\,\}text{In}$ multichannel mode, TFSx enable and TFSx valid follow t_{DTENLFS} and $t_{\text{DDTLFSE}}.$

² Applicable to multichannel mode only.

³TSCLKx is tied to RSCLKx.

 $^{^2} If \ external \ RFSx/TFSx \ setup \ to \ RSCLKx/TSCLKx > t_{SCLKE}/2, \ then \ t_{DDTTE/I} \ and \ t_{DTENE/I} \ apply; \ otherwise \ t_{DDTLFSE} \ and \ t_{DTENLFS} \ apply.$

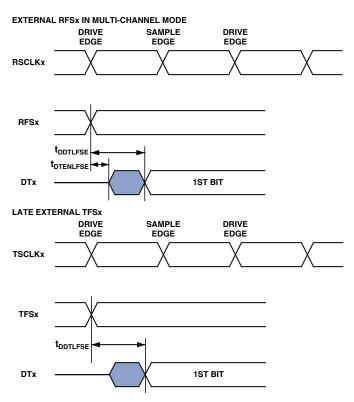


Figure 27. External Late Frame Sync

Serial Peripheral Interface Ports—Master Timing

Table 34 and Figure 28 describe SPI ports master operations.

Table 34. Serial Peripheral Interface (SPI) Ports—Master Timing

| Parameter | | Min Max | Unit |
|----------------------|--|--------------------------|------|
| Timing Requ | irements | | |
| t _{SSPIDM} | Data Input Valid to SCKx Edge (Data Input Setup) | 9.0 | ns |
| t _{HSPIDM} | SCKx Sampling Edge to Data Input Invalid | -1.5 | ns |
| Switching Ch | naracteristics | | |
| t_{SDSCIM} | SPIxSELy Low to First SCKx edge | 2t _{SCLK} -1.5 | ns |
| t _{SPICHM} | Serial Clock High Period | 2t _{SCLK} – 1.5 | ns |
| t_{SPICLM} | Serial Clock Low Period | 2t _{SCLK} – 1.5 | ns |
| t _{SPICLK} | Serial Clock Period | 4t _{SCLK} -1.5 | ns |
| t _{HDSM} | Last SCKx Edge to SPIxSELy High | 2t _{SCLK} -1.5 | ns |
| t_{SPITDM} | Sequential Transfer Delay | 2t _{SCLK} -1.5 | ns |
| t _{DDSPIDM} | SCKx Edge to Data Out Valid (Data Out Delay) | 5 | ns |
| t _{HDSPIDM} | SCKx Edge to Data Out Invalid (Data Out Hold) | -1.0 | ns |

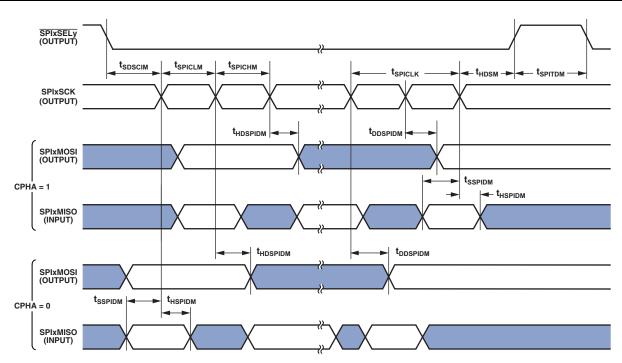


Figure 28. Serial Peripheral Interface (SPI) Ports—Master Timing

Serial Peripheral Interface Ports—Slave Timing

Table 35 and Figure 29 describe SPI ports slave operations.

Table 35. Serial Peripheral Interface (SPI) Ports—Slave Timing

| Parameter | | Min | Max | Unit |
|---------------------|--|--------------------------|-----|------|
| Timing Requ | irements | | | |
| t _{SPICHS} | Serial Clock High Period | 2t _{SCLK} – 1.5 | | ns |
| t _{SPICLS} | Serial Clock Low Period | 2t _{SCLK} – 1.5 | | ns |
| t _{SPICLK} | Serial Clock Period | 4t _{SCLK} | | ns |
| t _{HDS} | Last SCKx Edge to SPIxSS Not Asserted | 2t _{SCLK} -1.5 | | ns |
| t _{SPITDS} | Sequential Transfer Delay | 2t _{SCLK} -1.5 | | ns |
| t _{SDSCI} | SPIxSS Assertion to First SCKx Edge | 2t _{SCLK} -1.5 | | ns |
| t _{SSPID} | Data Input Valid to SCKx Edge (Data Input Setup) | 2.0 | | ns |
| t _{HSPID} | SCKx Sampling Edge to Data Input Invalid | 2.0 | | ns |
| Switching Ci | haracteristics | | | |
| t _{DSOE} | SPIxSS Assertion to Data Out Active | 0 | 8 | ns |
| t _{DSDHI} | SPIxSS Deassertion to Data High impedance | 0 | 8 | ns |
| t _{DDSPID} | SCKx Edge to Data Out Valid (Data Out Delay) | | 10 | ns |
| t _{HDSPID} | SCKx Edge to Data Out Invalid (Data Out Hold) | 0 | | ns |

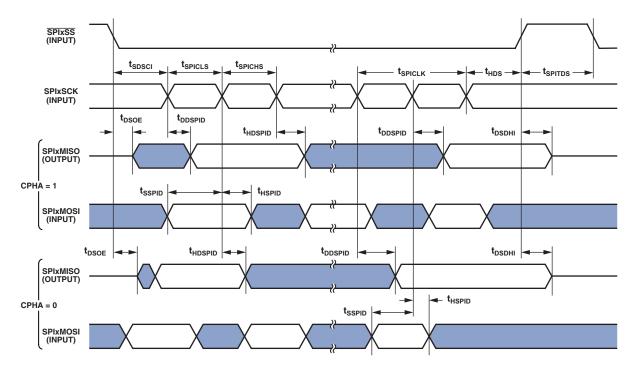


Figure 29. Serial Peripheral Interface (SPI) Ports—Slave Timing

General-Purpose Port Timing

Table 36 and Figure 30 describe general-purpose operations.

Table 36. General-Purpose Port Timing

| Parameter | r | Min | Max | Unit |
|-------------|--|-----------------------|-----|------|
| Timing Req | uirement | | | |
| t_{WFI} | GP Port Pin Input Pulse Width | t _{SCLK} + 1 | | ns |
| Switching (| Characteristic | | | |
| t_{GPOD} | GP Port Pin Output Delay from CLKOUT Low | | 6 | ns |

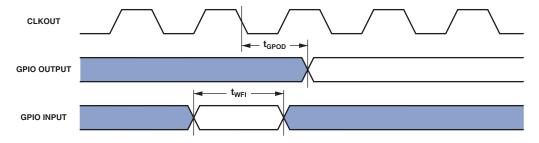


Figure 30. General-Purpose Port Cycle Timing

Universal Asynchronous Receiver-Transmitter (UART) Ports—Receive and Transmit Timing

For information on the UART port receive and transmit operations, see the *ADSP-BF539 Hardware Reference Manual*.

MXVR Timing

Table 37 and Table 38 describe the MXVR timing requirements.

Table 37. MXVR Timing—MXI Center Frequency Requirements

| Parameter | | $f_S = 38 \text{ kHz}$ | f _s = 44.1 kHz | $f_S = 48 \text{ kHz}$ | Unit |
|------------------|----------------------|------------------------|---------------------------|------------------------|------|
| f _{MXI} | MXI Center Frequency | 38.912 | 45.1584 | 49.152 | MHz |

Table 38. MXVR Timing— MXI Clock Requirements

| Parameter | | Min | Max | Unit |
|--------------|--|------|------|------|
| Timing Requi | rements | | | |
| FS_{MXI} | MXI Clock Frequency Stability | -50 | +50 | ppm |
| FT_MXI | MXI Frequency Tolerance Over Temperature | -300 | +300 | ppm |
| DC_{MXI} | MXI Clock Duty Cycle | 40 | 60 | % |

Timer Clock Timing

Table 39 and Figure 31 describe timer clock timing.

Table 39. Timer Clock Timing

| Paramet | ter | Min | Max | Unit |
|------------|--|-----|-----|------|
| Switching | g Characteristic | | | |
| t_{TODP} | Timer Output Update Delay After PPI_CLK High | | 12 | ns |

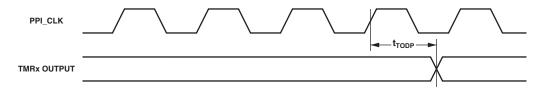


Figure 31. Timer Clock Timing

Timer Cycle Timing

Table 40 and Figure 32 describe timer expired operations. The input signal is asynchronous in "width capture mode" and "external clock mode" and has an absolute maximum input frequency of $f_{SCLK}/2$ MHz.

Table 40. Timer Cycle Timing

| | V _D | _{DEXT} = 1.8 V | V _{DDEXT} | | |
|--|-----------------------|----------------------------------|---------------------------|-----------------------------|------|
| Parameter | Min | Max | Min | Max | Unit |
| Timing Characteristics | | | | | |
| t _{WL} Timer Pulse Width Low ¹ | $1 \times t_{SCLK}$ | | $1 \times t_{SCLK}$ | | ns |
| t _{WH} Timer Pulse Width High ¹ | $1 \times t_{SCLK}$ | | $1 \times t_{SCLK}$ | | ns |
| t _{TIS} Timer Input Setup Time Before CLKOUT Low ² | 8.0 | | 6.5 | | ns |
| t_{TIH} Timer Input Hold Time After CLKOUT Low ² | 1.5 | | 1.5 | | ns |
| Switching Characteristics | | | | | |
| t _{HTO} Timer Pulse Width Output | $1 \times t_{SCLK}$ | $(2^{32}-1) \times t_{SCLK}$ 7.5 | $1 \times t_{SCLK}$ | $(2^{32}-1)\times t_{SCLK}$ | ns |
| t _{TOD} Timer Output Update Delay After CLKOUT High | | 7.5 | | 6.5 | ns |

¹ The minimum pulse widths apply for TMRx input pins in width capture and external clock modes. They also apply to the PF1 or PPI_CLK input pins in PWM output mode. ² Either a valid setup and hold time or a valid pulse width is sufficient. There is no need to resynchronize programmable flag inputs.

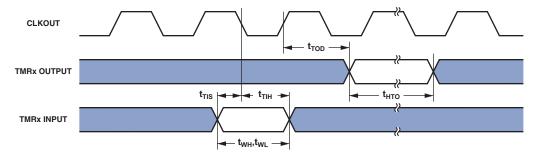


Figure 32. Timer PWM_OUT Cycle Timing

JTAG Test and Emulation Port Timing

Table 41 and Figure 33 describe JTAG port operations.

Table 41. JTAG Port Timing

| Parameter | | Min | Max | Unit |
|--------------------|--|-----|-----|------|
| Timing Requ | uirements | | | |
| t_{TCK} | TCK Period | 20 | | ns |
| t _{STAP} | TDI, TMS Setup Before TCK High | 4 | | ns |
| t _{HTAP} | TDI, TMS Hold After TCK High | 4 | | ns |
| t _{SSYS} | System Inputs Setup Before TCK High ¹ | 4 | | ns |
| t _{HSYS} | System Inputs Hold After TCK High ¹ | 6 | | ns |
| t _{TRSTW} | TRST Pulse Width ² (Measured in TCK Cycles) | 4 | | TCK |
| Switching C | haracteristics | | | |
| t_{DTDO} | TDO Delay from TCK Low | | 10 | ns |
| t _{DSYS} | System Outputs Delay After TCK Low ³ | 0 | 12 | ns |

¹ System Inputs = ARDY, BMODE1-0, \$\overline{BR}\$, DATA15-0, \$\overline{NMI}\$, PF15-0, PPI_CLK, PPI3-0, SCL1-0, SDA1-0, \$\overline{MTXON}\$, \$\overline{MTXON}\$, \$\overline{MRXON}\$, \$\ov

 $^{^{3}} System \ Outputs = \overline{AMS}, \overline{AOE}, \overline{ARE}, \overline{AWE}, \overline{ABE}, \overline{BG}, DATA15-0, PF15-0, PP13-0, \overline{MTXON}, MMCLK, MBCLK, MFS, MTX, \overline{SPI1SE}, \overline{SPI1SELI}, SCK2-0, MISO2-0, MOSI2-0, \overline{SPI2SE}, \overline{SPI2SELI}, RX2-1, TX2-0, DT2PRI, DT2SEC, DR2PRI, DR2SEC, DT3PRI, DT3SEC, DR3PRI, DR3SEC, TSCLK3-0, RFS3-0, CLKOUT, CANTX, SA10, \overline{SCAS}, SCKE, \overline{SMS}, \overline{SRAS}, \overline{SWE}, and TMR2-0.$

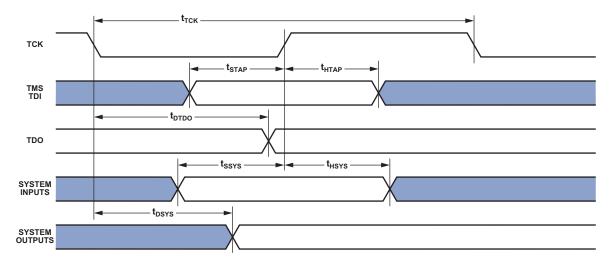


Figure 33. JTAG Port Timing

 $^{^2}$ 50 MHz maximum

OUTPUT DRIVE CURRENTS

The following figures show typical current-voltage characteristics for the output drivers of the ADSP-BF539/ADSP-BF539F processor. The curves represent the current drive capability of the output drivers as a function of output voltage.

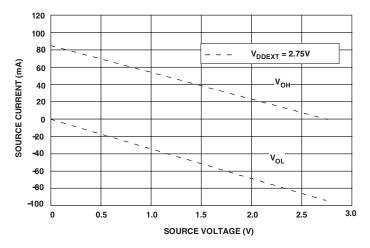


Figure 34. Drive Current A (Low V_{DDEXT})

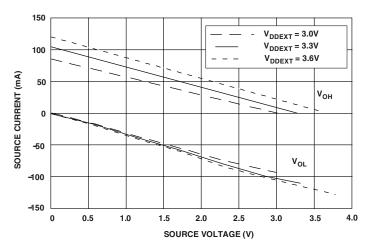


Figure 35. Drive Current A (High V_{DDEXT})

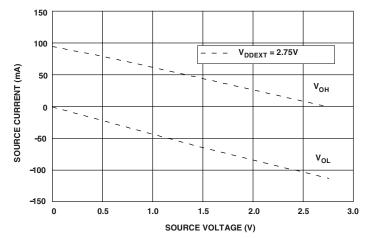


Figure 36. Drive Current B (Low V_{DDEXT})

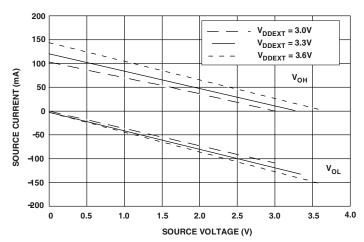


Figure 37. Drive Current B (High V_{DDEXT})

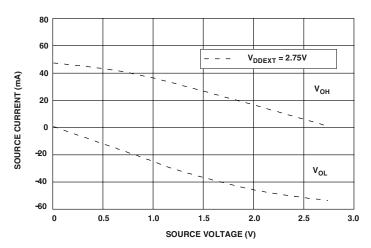


Figure 38. Drive Current C (Low V_{DDEXT})

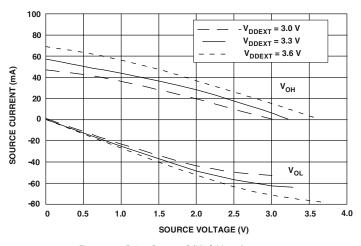


Figure 39. Drive Current C (High V_{DDEXT})

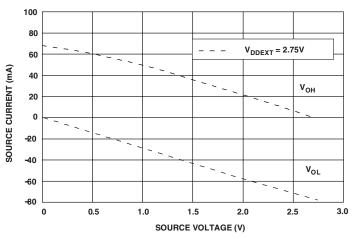


Figure 40. Drive Current D (Low V_{DDEXT})

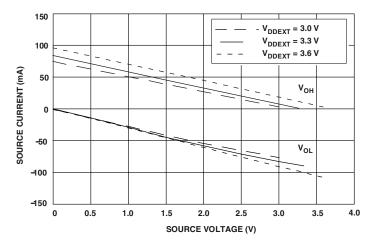


Figure 41. Drive Current D (High V_{DDEXT})

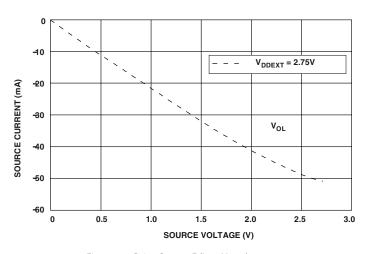


Figure 42. Drive Current E (Low V_{DDEXT})

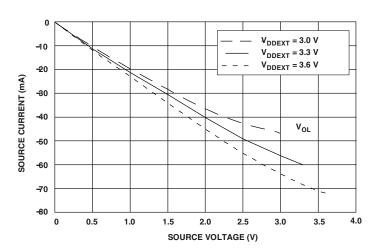


Figure 43. Drive Current E (High V_{DDEXT})

TEST CONDITIONS

All timing parameters appearing in this data sheet were measured under the conditions described in this section. Figure 44 shows the measurement point for ac measurements (except output enable/disable). The measurement point V_{MEAS} is 1.5 V for V_{DDEXT} (nominal) = 3.3 V.



Figure 44. Voltage Reference Levels for AC Measurements (Except Output Enable/Disable)

Output Enable Time Measurement

Output pins are considered to be enabled when they have made a transition from a high impedance state to the point when they start driving.

The output enable time $t_{\rm ENA}$ is the interval from the point when a reference signal reaches a high or low voltage level to the point when the output starts driving as shown on the right side of Figure 45 on Page 52.

The time $t_{ENA_MEASURED}$ is the interval, from when the reference signal switches, to when the output voltage reaches $V_{TRIP}(high)$ or $V_{TRIP}(low)$. $V_{TRIP}(high)$ is 2.0 V and $V_{TRIP}(low)$ is 1.0 V for V_{DDEXT} (nominal) = 3.3 V. Time t_{TRIP} is the interval from when the output starts driving to when the output reaches the $V_{TRIP}(high)$ or $V_{TRIP}(low)$ trip voltage.

Time t_{ENA} is calculated as shown in the equation:

$$t_{ENA} = t_{ENA_MEASURED} - t_{TRIP}$$

If multiple pins (such as the data bus) are enabled, the measurement value is that of the first pin to start driving.

Output Disable Time Measurement

Output pins are considered to be disabled when they stop driving, go into a high impedance state, and start to decay from their output high or low voltage. The output disable time t_{DIS} is the difference between $t_{DIS_MEASURED}$ and t_{DECAY} as shown on the left side of Figure 45.

$$t_{DIS} = t_{DIS_MEASURED} - t_{DECAY}$$

The time for the voltage on the bus to decay by ΔV is dependent on the capacitive load C_L and the load current I_L . This decay time can be approximated by the equation:

$$t_{DECAY} = (C_L \Delta V) / I_L$$

The time t_{DECAY} is calculated with test loads C_L and I_L , and with ΔV equal to 0.5 V for V_{DDEXT} (nominal) = 3.3 V.

The time $t_{DIS+_MEASURED}$ is the interval from when the reference signal switches, to when the output voltage decays ΔV from the measured output high or output low voltage.

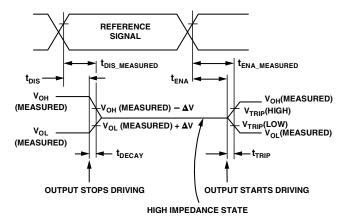


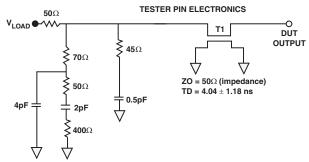
Figure 45. Output Enable/Disable

Example System Hold Time Calculation

To determine the data output hold time in a particular system, first calculate $t_{\rm DECAY}$ using the equation given above. Choose ΔV to be the difference between the ADSP-BF539/ADSP-BF539F processor output voltage and the input threshold for the device requiring the hold time. C_L is the total bus capacitance (per data line), and I_L is the total leakage or three-state current (per data line). The hold time is $t_{\rm DECAY}$ plus the various output disable times as specified in the Timing Specifications on Page 31 (for example, $t_{\rm DSDAT}$ for an SDRAM write cycle as shown in Table 26 on Page 36).

Capacitive Loading

Output delays and holds are based on standard capacitive loads: 30 pF on all pins (see Figure 46). $V_{\rm LOAD}$ is 1.5 V for $V_{\rm DDEXT}$ (nominal) = 3.3 V. Figure 47 on Page 53 through Figure 56 on Page 54 show how output rise and fall times vary with capacitance. The delay and hold specifications given should be derated by a factor derived from these figures. The graphs in these figures may not be linear outside the ranges shown.



NOTES:

THE WORST CASE TRANSMISSION LINE DELAY IS SHOWN AND CAN BE USED FOR THE OUTPUT TIMING ANALYSIS TO REFELECT THE TRANSMISSION LINE EFFECT AND MUST BE CONSIDERED. THE TRANSMISSION LINE (TD) IS FOR LOAD ONLY AND DOES NOT AFFECT THE DATA SHEET TIMING SPECIFICATIONS.

ANALOG DEVICES RECOMMENDS USING THE IBIS MODEL TIMING FOR A GIVEN SYSTEM REQUIREMENT. IF NECESSARY, A SYSTEM MAY INCORPORATE EXTERNAL DRIVERS TO COMPENSATE FOR ANY TIMING DIFFERENCES.

Figure 46. Equivalent Device Loading for AC Measurements (Includes All Fixtures)

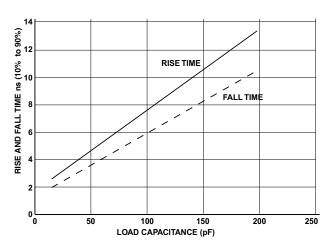


Figure 47. Typical Rise and Fall Times (10% to 90%) vs. Load Capacitance for Driver A at $V_{DDEXT} = 2.7 V$ (Min)

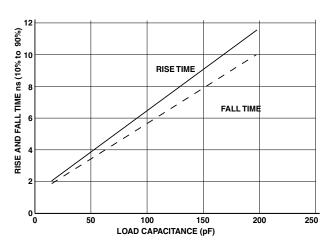


Figure 48. Typical Rise and Fall Times (10% to 90%) vs. Load Capacitance for Driver A at V_{DDEXT} = 3.65 V (Max)

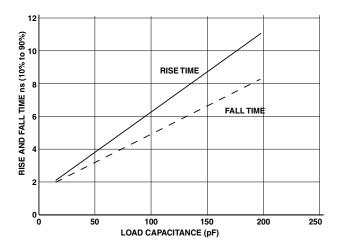


Figure 49. Typical Rise and Fall Times (10% to 90%) vs. Load Capacitance for Driver B at $V_{\rm DDEXT}=2.7~V$ (Min)

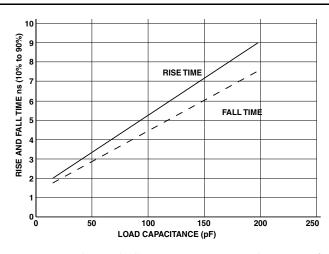


Figure 50. Typical Rise and Fall Times (10% to 90%) vs. Load Capacitance for Driver B at $V_{DDEXT} = 3.65 V$ (Max)

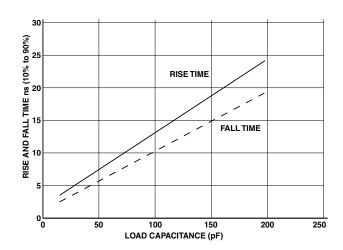


Figure 51. Typical Rise and Fall Times (10% to 90%) vs. Load Capacitance for $Driver\ C\ at\ V_{DDEXT}=2.7\ V\ (Min)$

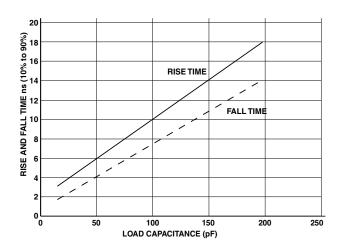


Figure 52. Typical Rise and Fall Times (10% to 90%) vs. Load Capacitance for Driver C at $V_{DDEXT} = 3.65 \ V(Max)$

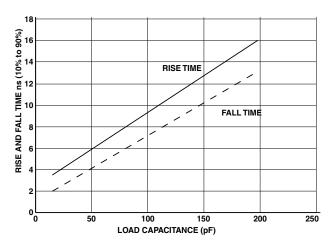


Figure 53. Typical Rise and Fall Times (10% to 90%) vs. Load Capacitance for Driver D at $V_{DDEXT} = 2.7 V$ (Min)

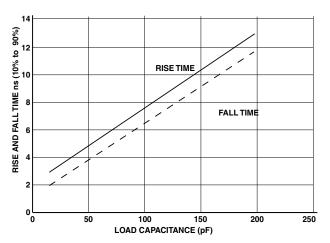


Figure 54. Typical Rise and Fall Times (10% to 90%) vs. Load Capacitance for Driver D at V_{DDEXT} = 3.65 V (Max)

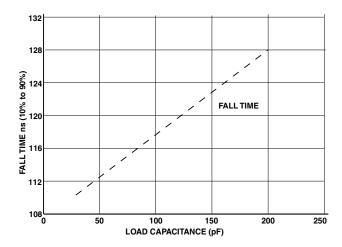


Figure 55. Typical Fall Time (10% to 90%) vs. Load Capacitance for Driver E at $V_{DDEXT} = 2.7 V$ (Min)

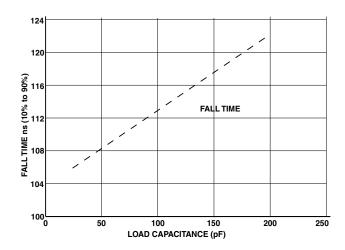


Figure 56. Typical Fall Time (10% to 90%) vs. Load Capacitance for Driver E at $V_{DDEXT} = 3.65 \text{ V (Max)}$

THERMAL CHARACTERISTICS

To determine the junction temperature on the application printed circuit board use

$$T_I = T_{CASE} + (\Psi_{IT} \times P_D)$$

where:

 T_I = junction temperature (°C)

 T_{CASE} = case temperature (°C) measured by customer at top center of package.

 Ψ_{IT} = from Table 42 or Table 43

 P_D = power dissipation (see Electrical Characteristics on Page 27 for the method to calculate P_D)

Values of θ_{JA} are provided for package comparison and printed circuit board design considerations. θ_{JA} can be used for a first order approximation of T_I by the equation:

$$T_I = T_A + (\theta_{IA} \times P_D)$$

where:

 T_A = ambient temperature (°C)

Values of θ_{JC} are provided for package comparison and printed circuit board design considerations when an external heatsink is required.

Values of θ_{JB} are provided for package comparison and printed circuit board design considerations.

In Table 42 and Table 43, airflow measurements comply with JEDEC standards JESD51-2 and JESD51-6, and the junction-to-board measurement complies with JESD51-8. The junction-to-case measurement complies with MIL-STD-883 (Method 1012.1). All measurements use a 2S2P JEDEC test board.

Table 42. Thermal Characteristics BC-316 Without Flash

| Parameter | Condition | Typical | Unit |
|-----------------------|-----------------------|---------|------|
| θ_{JA} | 0 linear m/s air flow | 25.4 | °C/W |
| θ_{JMA} | 1 linear m/s air flow | 22.8 | °C/W |
| θ_{JMA} | 2 linear m/s air flow | 22.0 | °C/W |
| θ_{JC} | | 6.7 | °C/W |
| $\Psi_{	extsf{JT}}$ | 0 linear m/s air flow | 0.18 | °C/W |
| Ψ_{JT} | 1 linear m/s air flow | 0.38 | °C/W |
| $\Psi_{	extsf{JT}}$ | 2 linear m/s air flow | 0.40 | °C/W |

Table 43. Thermal Characteristics BC-316 With Flash

| Parameter | Condition | Typical | Unit |
|-----------------------|-----------------------|---------|------|
| θ_{JA} | 0 linear m/s air flow | 24.3 | °C/W |
| θ_{JMA} | 1 linear m/s air flow | 21.8 | °C/W |
| θ_{JMA} | 2 linear m/s air flow | 21.0 | °C/W |
| θ_{JC} | | 6.3 | °C/W |
| Ψ_{JT} | 0 linear m/s air flow | 0.17 | °C/W |
| Ψ_{JT} | 1 linear m/s air flow | 0.36 | °C/W |
| Ψ_{JT} | 2 linear m/s air flow | 0.38 | °C/W |

316-BALL CSP_BGA BALL ASSIGNMENT

Figure 57 lists the top view of the CSP_BGA ball assignment. Figure 58 lists the bottom view of the CSP_BGA ball assignment.

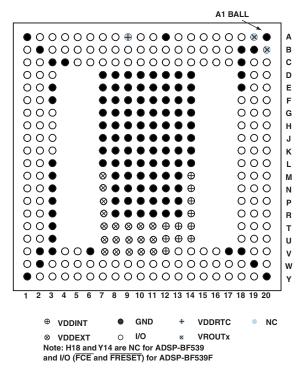


Figure 57. 316-Ball CSP_BGA Ball Assignment (Top View)

Table 44 on Page 57 lists the CSP_BGA ball assignment by ball number. Table 45 on Page 58 lists the CSP_BGA ball assignment by signal.

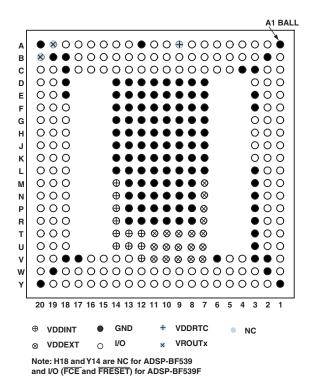


Figure 58. 316-Ball CSP_BGA Ball Assignment (Bottom View)

Table 44. 316-Ball CSP_BGA Ball Assignment (Numerically by Ball Number)

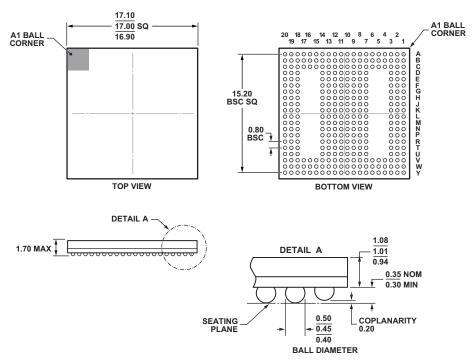
| Ball No. | Signal | Ball No. | Signal | Ball No. | Signal | Ball No. | Signal | Ball No. | Signal | Ball No. | Signal | Ball No. | Signal |
|----------|-------------|----------|----------|----------|--------|----------|--------------------|----------|--------------------|----------|--------------------|----------|--------|
| A1 | GND | C7 | SPI2SEL1 | F8 | GND | J12 | GND | M19 | ABE0 | T3 | GND | W1 | TCK |
| A2 | PF10 | C8 | SPI2SS | F9 | GND | J13 | GND | M20 | ABE1 | T7 | V_{DDEXT} | W2 | GND |
| A3 | PF11 | C9 | MOSI2 | F10 | GND | J14 | GND | N1 | TFS0 | T8 | V_{DDEXT} | W3 | DATA15 |
| A4 | PPI_CLK | C10 | MISO2 | F11 | GND | J18 | AMS0 | N2 | DR0PRI | T9 | V_{DDEXT} | W4 | DATA13 |
| A5 | PPI0 | C11 | SCK2 | F12 | GND | J19 | AMS2 | N3 | GND | T10 | V_{DDEXT} | W5 | DATA11 |
| A6 | PPI2 | C12 | MPIVDD | F13 | GND | J20 | SA10 | N7 | V_{DDEXT} | T11 | V_{DDEXT} | W6 | DATA9 |
| A7 | PF15 | C13 | SPI1SEL1 | F14 | GND | K1 | RFS1 | N8 | GND | T12 | V_{DDINT} | W7 | DATA7 |
| A8 | PF13 | C14 | MISO1 | F18 | DT3PRI | K2 | TMR2 | N9 | GND | T13 | V_{DDINT} | W8 | DATA5 |
| A9 | V_{DDRTC} | C15 | SPI1SS | F19 | MRX | K3 | GP | N10 | GND | T14 | V_{DDINT} | W9 | DATA3 |
| A10 | RTXO | C16 | MOSI1 | F20 | MFS | K7 | GND | N11 | GND | T18 | RFS3 | W10 | DATA1 |
| A11 | RTXI | C17 | SCK1 | G1 | SCK0 | K8 | GND | N12 | GND | T19 | ADDR7 | W11 | RSCLK2 |
| A12 | GND | C18 | GND | G2 | MOSI0 | K9 | GND | N13 | GND | T20 | ADDR8 | W12 | DR2PRI |
| A13 | CLKIN | C19 | MMCLK | G3 | DT0SEC | K10 | GND | N14 | V_{DDINT} | U1 | TRST | W13 | DT2PRI |
| A14 | XTAL | C20 | SCKE | G7 | GND | K11 | GND | N18 | DT3SEC | U2 | TMS | W14 | RX2 |
| A15 | MLF | D1 | PF4 | G8 | GND | K12 | GND | N19 | ADDR1 | U3 | GND | W15 | TX2 |
| A16 | MXO | D2 | PF5 | G9 | GND | K13 | GND | N20 | ADDR2 | U7 | V_{DDEXT} | W16 | ADDR18 |
| A17 | MXI | D3 | DT1SEC | G10 | GND | K14 | GND | P1 | TSCLK0 | U8 | V_{DDEXT} | W17 | ADDR15 |
| A18 | MRXON | D7 | GND | G11 | GND | K18 | AMS3 | P2 | RFS0 | U9 | V_{DDEXT} | W18 | ADDR13 |
| A19 | VROUT1 | D8 | GND | G12 | GND | K19 | AMS1 | P3 | GND | U10 | V_{DDEXT} | W19 | GND |
| A20 | GND | D9 | GND | G13 | GND | K20 | AOE | P7 | V_{DDEXT} | U11 | V_{DDEXT} | W20 | ADDR14 |
| B1 | PF8 | D10 | GND | G14 | GND | L1 | RSCLK1 | P8 | GND | U12 | V_{DDINT} | Y1 | GND |
| B2 | GND | D11 | GND | G18 | BR | L2 | TMR1 | P9 | GND | U13 | V_{DDINT} | Y2 | TDO |
| B3 | PF9 | D12 | GND | G19 | | L3 | GND | P10 | GND | U14 | V_{DDINT} | Y3 | DATA14 |
| B4 | PF3 | D13 | GND | G20 | SRAS | L7 | GND | P11 | GND | U18 | RSCLK3 | Y4 | DATA12 |
| B5 | PPI1 | D14 | GND | H1 | DT1PRI | L8 | GND | P12 | GND | U19 | ADDR9 | Y5 | DATA10 |
| B6 | PPI3 | D18 | GND | H2 | TSCLK1 | L9 | GND | P13 | GND | U20 | ADDR10 | Y6 | DATA8 |
| В7 | PF14 | D19 | MBCLK | H3 | | L10 | GND | P14 | V_{DDINT} | V1 | TDI | Y7 | DATA6 |
| B8 | PF12 | D20 | SMS | H7 | GND | L11 | GND | P18 | DR3SEC | V2 | GND | Y8 | DATA4 |
| B9 | SCL0 | E1 | PF1 | H8 | GND | L12 | GND | P19 | ADDR3 | V3 | GND | Y9 | DATA2 |
| B10 | SDA0 | E2 | PF2 | H9 | GND | L13 | GND | P20 | ADDR4 | V4 | BMODE1 | Y10 | DATA0 |
| B11 | CANRX | E3 | GND | H10 | GND | L14 | GND | R1 | TX0 | V5 | BMODE0 | Y11 | RFS2 |
| B12 | CANTX | E7 | GND | H11 | GND | L18 | TSCLK3 | R2 | RSCLK0 | V6 | GND | Y12 | TSCLK2 |
| B13 | NMI | E8 | | H12 | GND | L19 | ARE | R3 | GND | V7 | V_{DDEXT} | Y13 | TFS2 |
| B14 | | E9 | GND | H13 | GND | L20 | AWE | | V_{DDEXT} | V8 | V_{DDEXT} | Y14 | FRESET |
| B15 | | E10 | GND | H14 | GND | M1 | DT0PRI | R8 | GND | V9 | V_{DDEXT} | Y15 | SCL1 |
| B16 | | E11 | GND | H18 | FCE | M2 | TMR0 | R9 | GND | V10 | V_{DDEXT} | Y16 | SDA1 |
| B17 | | E12 | GND | H19 | SCAS | M3 | GND | R10 | GND | V11 | V _{DDEXT} | Y17 | ADDR19 |
| B18 | GND | E13 | GND | H20 | SWE | M7 | V _{DDEXT} | R11 | GND | V12 | V _{DDINT} | Y18 | ADDR17 |
| B19 | GND | E14 | GND | J1 | | M8 | GND | R12 | GND | V13 | DR2SEC | Y19 | ADDR16 |
| B20 | VROUT0 | E18 | GND | J2 | DR1PRI | M9 | GND | R13 | GND | V14 | BG | Y20 | GND |
| C1 | PF6 | E19 | MTX | J3 | DROSEC | M10 | GND | R14 | V _{DDINT} | V15 | BGH | | |
| C2 | PF7 | E20 | ARDY | J7 | GND | M11 | GND | R18 | DR3PRI | V16 | DT2SEC | | |
| C3 | GND | F1 | PF0 | J8 | GND | M12 | GND | R19 | ADDR5 | V17 | GND | | |
| C4 | GND | F2 | MISO0 | J9 | GND | M13 | GND | R20 | ADDR6 | V18 | GND | | |
| C5 | RX1 | F3 | GND | J10 | GND | M14 | V _{DDINT} | T1 | RX0 | V19 | ADDR11 | | |
| C6 | TX1 | F7 | GND | J11 | GND | M18 | TFS3 | T2 | EMU | V20 | ADDR12 | | |

Table 45. 316-Ball CSP_BGA Ball Assignment (Alphabetically by Signal)

| Signal | Ball No. | Signal | Ball No. | Signal | Ball No. | Signal | Ball No. |
|--------|----------|--------|----------|--------|----------|--------|----------|---------|----------|----------|----------|--------------------|----------|
| ABE0 | M19 | DATA8 | Y6 | GND | E7 | GND | K11 | GND | V17 | PPI2 | A6 | TSCLK1 | H2 |
| ABE1 | M20 | DATA9 | W6 | GND | E8 | GND | K12 | GND | V18 | PPI3 | B6 | TSCLK2 | Y12 |
| ADDR1 | N19 | DATA10 | Y5 | GND | E9 | GND | K13 | GND | W2 | RESET | B14 | TSCLK3 | L18 |
| ADDR2 | N20 | DATA11 | W5 | GND | F8 | GND | L13 | GND | W19 | RFS0 | P2 | TX0 | R1 |
| ADDR3 | P19 | DATA12 | Y4 | GND | F9 | GND | L14 | GND | Y1 | RFS1 | K1 | TX1 | C6 |
| ADDR4 | P20 | DATA13 | W4 | GND | F10 | GND | M3 | GND | Y20 | RFS2 | Y11 | TX2 | W15 |
| ADDR5 | R19 | DATA14 | Y3 | GND | F11 | GND | M8 | GP | K3 | RFS3 | T18 | V_{DDEXT} | T8 |
| ADDR6 | R20 | DATA15 | W3 | GND | F12 | GND | M9 | MBCLK | D19 | RSCLK0 | R2 | V _{DDEXT} | T9 |
| ADDR7 | T19 | DROPRI | N2 | GND | F13 | GND | M10 | MFS | F20 | RSCLK1 | L1 | V_{DDEXT} | T10 |
| ADDR8 | T20 | DROSEC | J3 | GND | F14 | GND | M11 | MISO0 | F2 | RSCLK2 | W11 | V _{DDEXT} | T11 |
| ADDR9 | U19 | DR1PRI | J2 | GND | G7 | GND | M12 | MISO1 | C14 | RSCLK3 | U18 | V _{DDEXT} | U7 |
| ADDR10 | U20 | DR1SEC | | GND | G8 | GND | M13 | MISO2 | C10 | RTXI | A11 | V _{DDEXT} | U8 |
| ADDR11 | V19 | DR2PRI | W12 | GND | G9 | GND | N3 | MLF | A15 | RTXO | A10 | V _{DDEXT} | U9 |
| ADDR12 | V20 | DR2SEC | V13 | GND | E10 | GND | K14 | MMCLK | C19 | RX0 | T1 | V _{DDEXT} | U10 |
| ADDR13 | W18 | DR3PRI | R18 | GND | E11 | GND | L3 | MOSI0 | G2 | RX1 | C5 | V _{DDEXT} | U11 |
| ADDR14 | W20 | DR3SEC | | GND | E12 | GND | L7 | MOSI1 | C16 | RX2 | W14 | V _{DDEXT} | V7 |
| ADDR15 | W17 | DTOPRI | M1 | GND | E13 | GND | L8 | MOSI2 | C9 | SA10 | J20 | V _{DDEXT} | M7 |
| ADDR16 | Y19 | DTOSEC | | GND | E14 | GND | L9 | MPIVDD | C12 | SCAS | H19 | V _{DDEXT} | N7 |
| ADDR17 | Y18 | DT1PRI | H1 | GND | E18 | GND | L10 | MRXON | A18 | SCK0 | G1 | V _{DDEXT} | P7 |
| ADDR18 | W16 | DT1SEC | D3 | GND | F3 | GND | L11 | MRX | F19 | SCK1 | C17 | V _{DDEXT} | R7 |
| ADDR19 | Y17 | DT2PRI | W13 | GND | F7 | GND | L12 | MTX | E19 | SCK2 | C11 | V _{DDEXT} | T7 |
| AMS0 | J18 | DT2SEC | V16 | GND | G10 | GND | N8 | MTXON | B17 | SCKE | C20 | V _{DDEXT} | V8 |
| AMS1 | K19 | DT3PRI | F18 | GND | G11 | GND | N9 | MXEGND | | SCL0 | В9 | V _{DDEXT} | V9 |
| AMS2 | J19 | DT3SEC | N18 | GND | G12 | GND | N10 | MXEVDD | B15 | SCL1 | Y15 | V _{DDEXT} | V10 |
| AMS3 | K18 | EMU | T2 | GND | G13 | GND | N11 | MXI | A17 | SDA0 | B10 | V _{DDEXT} | V11 |
| AOE | K20 | FCE | H18 | GND | G14 | GND | N12 | мхо | A16 | SDA1 | Y16 | V _{DDINT} | M14 |
| ARDY | E20 | FRESET | Y14 | GND | H7 | GND | N13 | NMI | B13 | SMS | D20 | V _{DDINT} | N14 |
| ARE | L19 | GND | A1 | GND | H8 | GND | Р3 | PF0 | F1 | SPI1SEL1 | | V _{DDINT} | P14 |
| AWE | L20 | GND | A12 | GND | H9 | GND | P8 | PF1 | E1 | SPI1SS | C15 | V_{DDINT} | R14 |
| BG | V14 | GND | A20 | GND | H10 | GND | P9 | PF2 | E2 | SPI2SEL1 | C7 | V_{DDINT} | T12 |
| BGH | V15 | GND | B2 | GND | H11 | GND | P10 | PF3 | B4 | SPI2SS | C8 | V_{DDINT} | T13 |
| BMODE0 | V5 | GND | B18 | GND | H12 | GND | P11 | PF4 | D1 | SRAS | G20 | V _{DDINT} | T14 |
| BMODE1 | V4 | GND | B19 | GND | H13 | GND | P12 | PF5 | D2 | SWE | H20 | V_{DDINT} | U12 |
| BR | G18 | GND | C3 | GND | H14 | GND | P13 | PF6 | C1 | TCK | W1 | V_{DDINT} | U13 |
| CANRX | B11 | GND | C4 | GND | J7 | GND | R3 | PF7 | C2 | TDI | V1 | V_{DDINT} | U14 |
| CANTX | B12 | GND | C18 | GND | J8 | GND | R8 | PF8 | B1 | TDO | Y2 | V_{DDINT} | V12 |
| CLKIN | A13 | GND | D7 | GND | J9 | GND | R9 | PF9 | В3 | TFS0 | N1 | V_{DDRTC} | A9 |
| CLKOUT | G19 | GND | D8 | GND | J10 | GND | R10 | PF10 | A2 | TFS1 | J1 | VROUT0 | B20 |
| DATA0 | Y10 | GND | D9 | GND | J11 | GND | R11 | PF11 | A3 | TFS2 | Y13 | VROUT1 | A19 |
| DATA1 | W10 | GND | D10 | GND | J12 | GND | R12 | PF12 | B8 | TFS3 | M18 | XTAL | A14 |
| DATA2 | Y9 | GND | D11 | GND | J13 | GND | R13 | PF13 | A8 | TMRO | M2 | | |
| DATA3 | W9 | GND | D12 | GND | J14 | GND | T3 | PF14 | B7 | TMR1 | L2 | | |
| DATA4 | Y8 | GND | D13 | GND | K7 | GND | U3 | PF15 | A7 | TMR2 | K2 | | |
| DATA5 | W8 | GND | D14 | GND | K8 | GND | V2 | PPI_CLK | A4 | TMS | U2 | | |
| DATA6 | Y7 | GND | D18 | GND | K9 | GND | V3 | PPI0 | A5 | TRST | U1 | | |
| DATA7 | W7 | GND | E3 | GND | K10 | GND | V6 | PPI1 | B5 | TSCLK0 | P1 | | |

OUTLINE DIMENSIONS

Dimensions in the outline dimensions figures are shown in millimeters.



COMPLIANT TO JEDEC STANDARDS MO-275-MMAB-1. WITH EXCEPTION TO BALL DIAMETER.

Figure 59. 316-Ball Chip Scale Package Ball Grid Array [CSP_BGA] (BC-316-2) Dimensions shown in millimeters

SURFACE-MOUNT DESIGN

Table 46 is provided as an aid to PCB design. For industry-standard design recommendations, refer to IPC-7351, Generic Requirements for Surface Mount Design and Land Pattern Standard.

Table 46. BGA Data for Use with Surface-Mount Design

| Package | Package Ball Attach | Package Solder Mask | Package Ball Pad |
|-----------------------------|---------------------|---------------------|------------------|
| | Type | Opening | Size |
| 316-Ball CSP_BGA (BC-316-2) | Solder Mask Defined | 0.40 mm diameter | 0.50 mm diameter |

ORDERING GUIDE

The models shown in the following table are available with controlled manufacturing to support the quality and reliability requirements of automotive applications. Note that these automotive models may have specifications that differ from the commercial models and designers should review the product

specifications section of this data sheet carefully. Contact your local ADI account representative for specific product ordering information and to obtain the specific Automotive Reliability reports for these models.

| Model ¹ | Temperature Range ² | Instruction Rate (Max) | Flash Memory | Package Description | Package Option |
|--------------------|-----------------------------------|---------------------------|-----------------|---------------------|-------------------|
| ADBF539WBBCZ4xx | -40°C to +85°C | 400 MHz | N/A | 316-Ball CSP_BGA | BC-316-2 |
| ADBF539WBBCZ5xx | -40°C to +85°C | 533 MHz | N/A | 316-Ball CSP_BGA | BC-316-2 |
| ADBF539WBBCZ4F8xx | -40°C to +85°C | 400 MHz | 8M bit | 316-Ball CSP_BGA | BC-316-2 |
| ADBF539WBBCZ5F8xx | -40°C to +85°C | 533 MHz | 8M bit | 316-Ball CSP_BGA | BC-316-2 |

 $^{^{1}}$ Z = RoHS compliant part.

² Referenced temperature is ambient temperature. The ambient temperature is not a specification. Please see Operating Conditions on Page 26 for junction temperature (T_j) specification which is the only temperature specification.